

## 4-TO-2 DVI/HDMI SWITCH

### FEATURES

- A 4-to-2 Single-Link or 2-to-1 Dual-Link DVI/HDMI Physical Layer Switch
- Compatible with HDMI 1.3a
- Supports 2.25 Gbps Signaling Rate for 480i/p, 720i/p, and 1080i/p Resolutions up to 12-Bit Color Depth
- Integrated Receiver Terminations
- 8-dB Receiver Equalizer Compensates for Losses From Standard HDMI Cables
- Selectable Output De-Emphasis Compensates for Losses From Flat Cables
- High-Impedance Outputs When Disabled
- I<sup>2</sup>C Repeater Isolates Bus Capacitance at Both Ends
- TMDS Inputs HBM ESD Protection Exceeds 6 kV
- 3.3-V Supply Operation
- 128-Pin TQFP Package
- ROHS Compatible and 260°C Reflow Rated

### APPLICATIONS

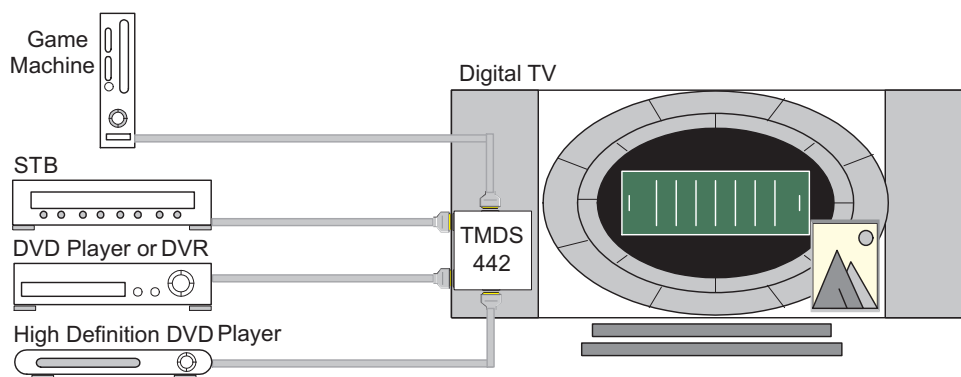
- Digital TV
- Digital Projector
- Audio Video Receiver
- DVI or HDMI Switch

### DESCRIPTION

The TMDS442, 4-to-2 port DVI/HDMI switch, allows up to 4 digital video interface (DVI) or high-definition multimedia interface (HDMI) ports to be switched to two independent display blocks. The essential requirement of picture-in-picture display from two digital audiovisual sources is having two individual DVI or HDMI receivers in a digital display system. TMDS442 supports two DVI or HDMI receivers to enable multiple-source selection (picture-in-picture), as well as supports acting as a 4-input 1-output video switch.

Each input or output port contains one 5-V power indicator (5V\_PWR), one hot plug detector (HPD), a pair of I<sup>2</sup>C interface signals (SCL/SDA), and four TMDS channels supporting data rates up to 2.25 Gbps. The 5-V power indicator and the hot plug detector are pulled down with internal resistors, forcing a low state on these pins until receiving a valid high signal. The I<sup>2</sup>C interface is constructed by an I<sup>2</sup>C repeater circuit to isolate the capacitance from both ends of the buses. TMDS receivers integrate 50-Ω termination resistors pulled up to V<sub>CC</sub>, which eliminates the need for external terminations. An 8-dB input equalization cooperates to each TMDS receiver inputs to optimize system performance through 5-meter or longer DVI or HDMI compliant cables.

### TYPICAL APPLICATION



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PowerPAD is a trademark of Texas Instruments.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of the Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

Copyright © 2006–2007, Texas Instruments Incorporated

A precision resistor is connected externally from the VSADJ pin to ground, for setting the differential output voltage to be compliant with the TMDS standard for all TMDS driver outputs. The PRE pin controls the TMDS output to be operated under either a standard TMDS mode or an AC de-emphasis mode. When PRE = high, a 3-dB AC de-emphasis TMDS output swing is selected to pre-condition the output signals to overcome signal impairments that may exist between the output of the TMDS442 and the HDMI receiver placed at a remote location.

Each sink output port can be configured with the SA, SB,  $\overline{OE}$ , I2CEN, and PRE pins. SA1, SB1,  $\overline{OE1}$ , I2CEN1, and PRE1 regulate the behaviour of sink port 1; SA2, SB2,  $\overline{OE2}$ , I2CEN2, and PRE2 regulate the behaviour of sink port 2. These control signals are hard-wire controlled by GPIO interface, or through a local I<sup>2</sup>C interface. When GE = low, the configurations are done through a local I<sup>2</sup>C interface, LC\_SCL, LC\_SDA, LC\_A0, and LC\_A1 pins, and the 5V\_EN can be programmed through the local I<sup>2</sup>C interface. It is default high after device powered on. When GE = high, the configurations are done through GPIO pins regardless the value of the 5V\_EN in the internal I<sup>2</sup>C registers.

The two bit source selector pins, SA and SB, determine the source transferred to the sink port. The internal multiplexer interconnects the TMDS channels and I<sup>2</sup>C interface from the selected source port to the sink port. The HPD output of the selected source port follows the status of the HPD\_SINK. Since two of the source ports will always be unconnected to any output, the I<sup>2</sup>C interfaces of unselected ports are isolated and the HPD outputs of an unselected port are pulled low.

The TMDS outputs of each of the sink ports are enabled based on the  $\overline{OE}$  signal and 5V\_PWR signal (from the selected source port). When  $\overline{OE}$  is low, for an output port, and the 5V\_PWR signal from the selected source port is high, the TMDS output signals are enabled; otherwise they are disabled, and high impedance.

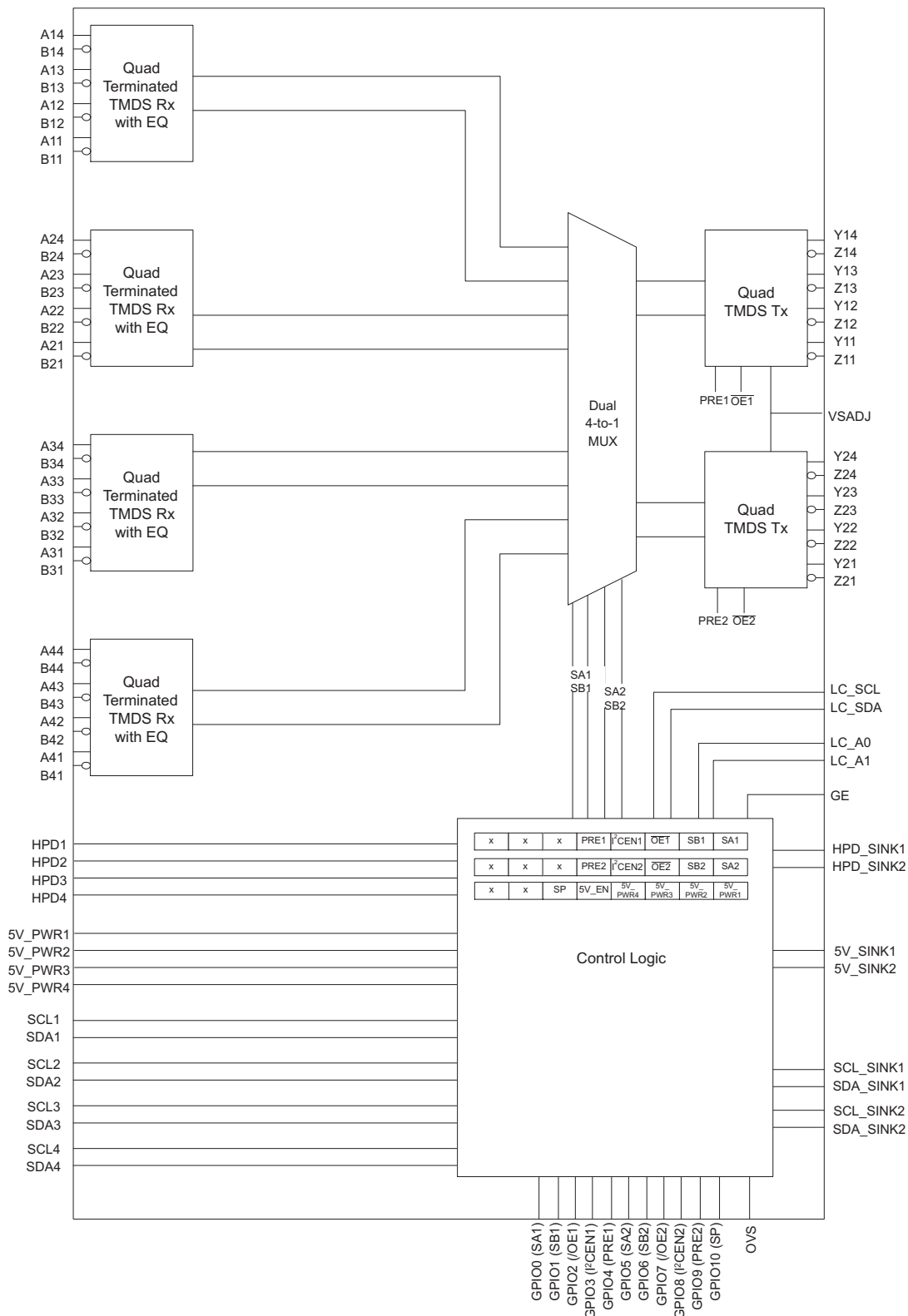
The I<sup>2</sup>C driver at sink side, SCL\_SINK and SDA\_SINK, are enabled by setting I2CEN high. When I2CEN is low, the I<sup>2</sup>C driver can not forward a low state to the I<sup>2</sup>C bus connected at the sink port. A hard wire output voltage select pin, OVS, allows adjustable output voltage level to SCL\_SINK and SDA\_SINK to optimise noise margins while interfacing to different HDMI receivers. The I<sup>2</sup>C driver of each source port, SCL and SDA, is controlled by its 5V\_PWR signal. A valid 5-V signal appearing at the input of 5V\_PWR enables the I<sup>2</sup>C driver of the source port.

The device is packaged in a 128-pin PowerPAD TQFP package and characterized for operation from 0°C to 70°C.

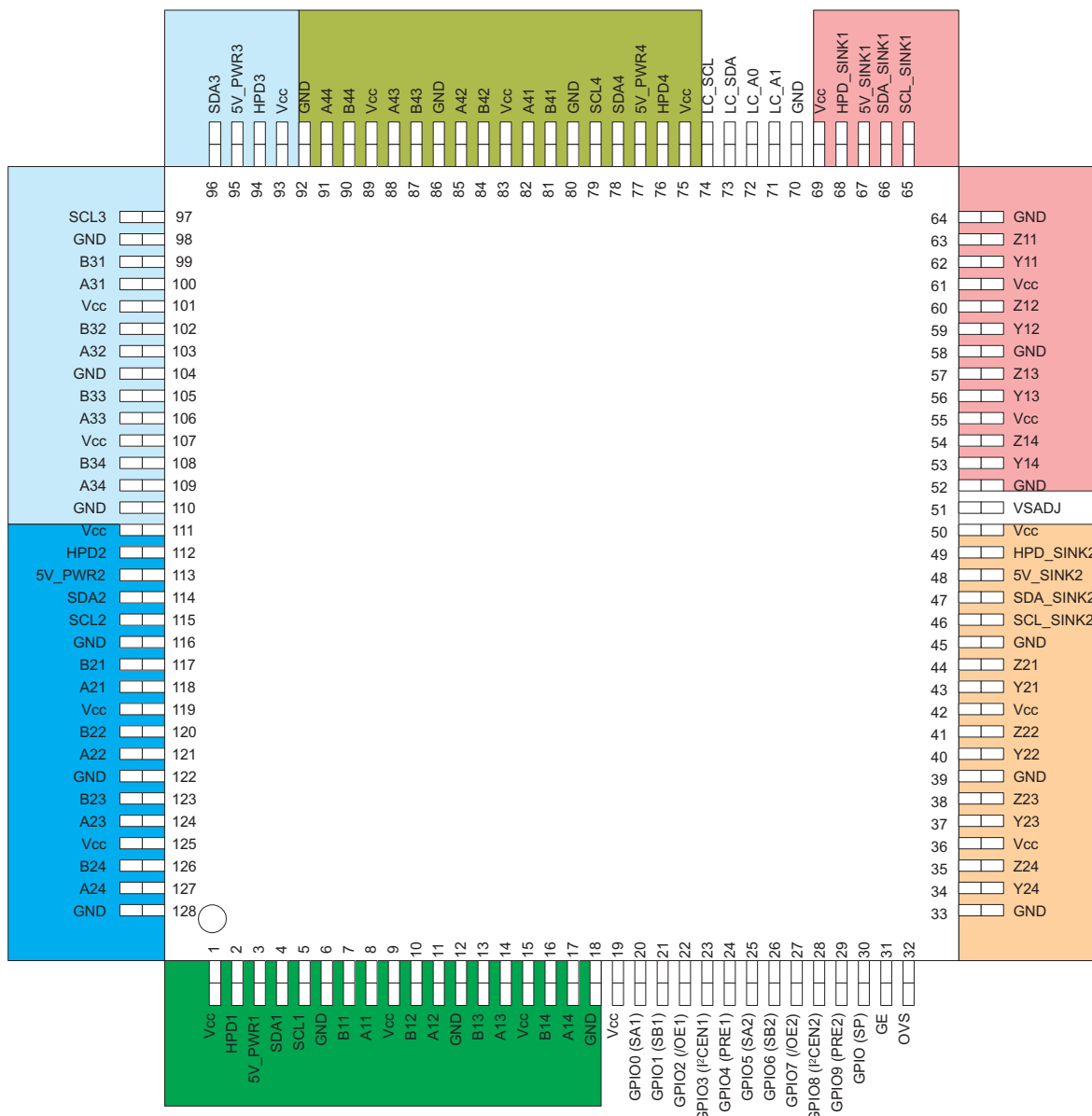


These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## FUNCTIONAL BLOCK DIAGRAM



**PNP PACKAGE  
(TOP VIEW)**



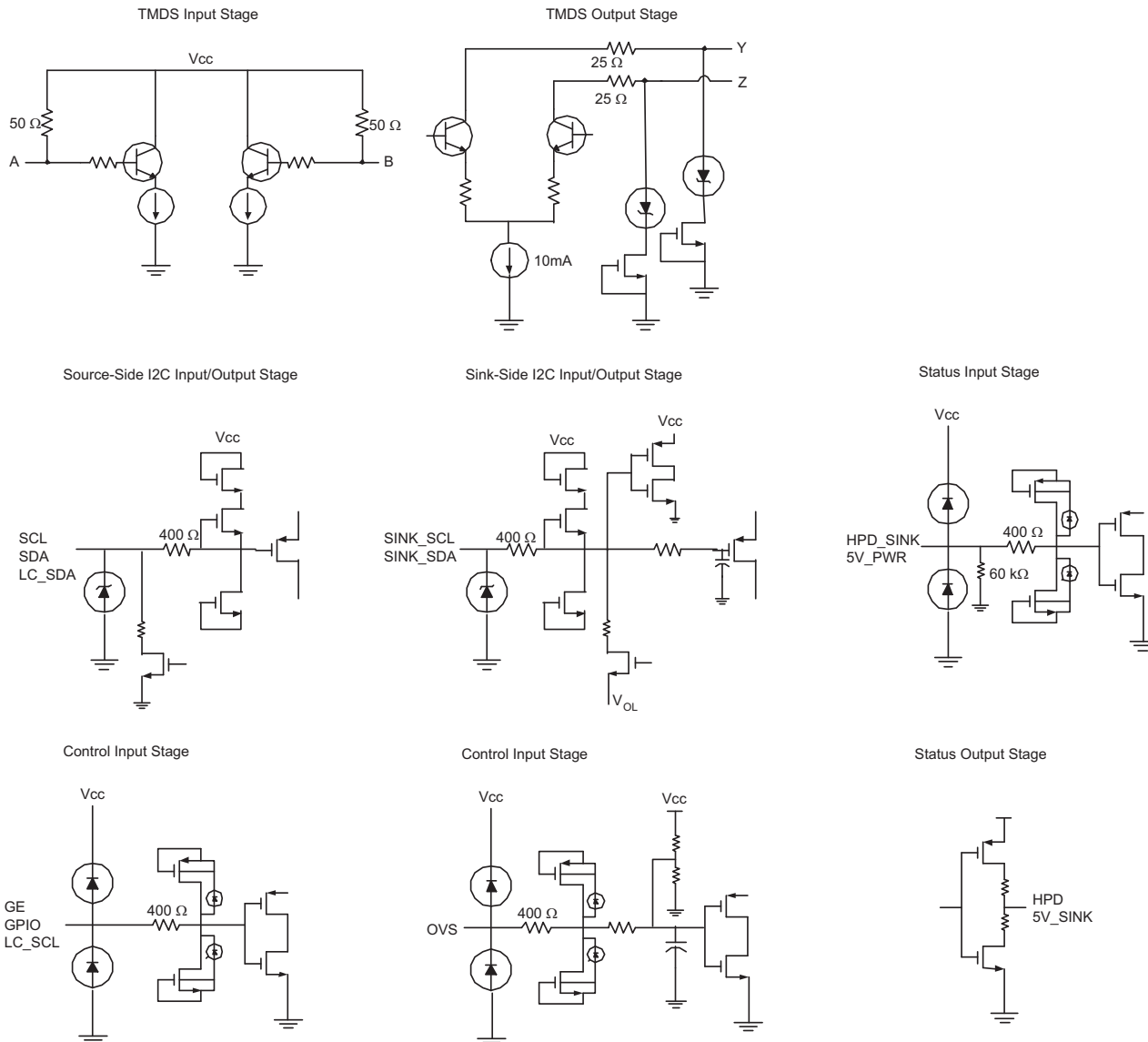
**TERMINAL FUNCTIONS**

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
A11, A12, A13, A14 A21, A22, A23, A24 A31, A32, A33, A34 A41, A42, A43, A44	8, 11, 14, 17 118, 121, 124, 127 100, 103, 106, 109 82, 85, 88, 91	I	Source port 1 TMDS positive inputs Source port 2 TMDS positive inputs Source port 3 TMDS positive inputs Source port 4 TMDS positive inputs
B11, B12, B13, B14 B21, B22, B23, B24 B31, B32, B33, B34 B41, B42, B43, B44	7, 10, 13, 16 117, 120, 123, 126 99, 102, 105, 108 81, 84, 87, 90	I	Source port 1 TMDS negative inputs Source port 2 TMDS negative inputs Source port 3 TMDS negative inputs Source port 4 TMDS negative inputs

**TERMINAL FUNCTIONS (continued)**

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
Y11, Y12, Y13, Y14 Y21, Y22, Y23, Y24	62, 59, 56, 53 43, 40, 37, 34	O	Sink port 1 TMDS positive outputs Sink port 2 TMDS positive outputs
Z11, Z12, Z13, Z14 Z21, Z22, Z23, Z24	63, 60, 57, 54 44, 41, 38, 35	O	Sink port 1 TMDS negative outputs Sink port 2 TMDS negative outputs
SCL1 SDA1	54	IO	Source Port 1 DDC I <sup>2</sup> C clock line Source Port 1 DDC I <sup>2</sup> C data line
SCL2 SDA2	115 114	IO	Source Port 2 DDC I <sup>2</sup> C clock line Source Port 2 DDC I <sup>2</sup> C data line
SCL3 SDA3	97 96	IO	Source Port 3 DDC I <sup>2</sup> C clock line Source Port 3 DDC I <sup>2</sup> C data line
SCL4 SDA4	79 78	IO	Source Port 4 DDC I <sup>2</sup> C clock line Source Port 4 DDC I <sup>2</sup> C data line
SCL_SINK1 SDA_SINK1	65 66	IO	Sink port 1 DDC I <sup>2</sup> C clock line Sink port 1 DDC I <sup>2</sup> C data line
SCL_SINK2 SDA_SINK2	46 47	IO	Sink port 2 DDC I <sup>2</sup> C clock line Sink port 2 DDC I <sup>2</sup> C data line
HPD1 HPD2 HPD3 HPD4	2 112 94 76	O	Source Port 1 hot plug detector output Source Port 2 hot plug detector output Source Port 3 hot plug detector output Source Port 4 hot plug detector output
HPD_SINK1 HPD_SINK2	68 49	I	Sink port 1 hot plug detector input Sink port 2 hot plug detector input
5V_PWR1 5V_PWR 2 5V_PWR 3 5V_PWR 4	3 113 95 77	I	Source Port 1 5-V power signal input Source Port 2 5-V power signal input Source Port 3 5-V power signal input Source Port 4 5-V power signal input
5V_SINK1 5V_SINK 2	67 48	O	Sink Port 1 5-V power indicator output Sink Port 2 5-V power indicator output
LC_SCL LC_SDA	74 73	IO	Local I <sup>2</sup> C clock line Local I <sup>2</sup> C data line
LC_A0 LC_A1	72 71	I	Local I <sup>2</sup> C address bit 0 Local I <sup>2</sup> C address bit 1
GE	31	I	GPIO Enable L: Local I <sup>2</sup> C pins are active, GPIO pins are high impedance H: GPIO pins are active, local I <sup>2</sup> C pins are high impedance
GPIO0 GPIO1 GPIO2 GPIO3 GPIO4	20 21 22 23 24	I	SA1 – Sink port 1 source selector SB1 – Sink port 1 source selector OE1 – Sink port 1 TMDS output enable I2CEN1 – Sink port 1 DDC I <sup>2</sup> C output enable PRE1 – Sink port 1 TMDS AC de-emphasis mode selector
GPIO5 GPIO6 GPIO7 GPIO8 GPIO9 GPIO10 GPIO11	25 26 27 28 29 30 32	I	SA2 – Sink port 2 source selector SB2 – Sink port 2 source selector OE2 – Sink port 2 TMDS output enable I2CEN2 – Sink port 2 DDC I <sup>2</sup> C output enable PRE2 – Sink port 2 TMDS AC de-emphasis mode selector SP – Sink priority selector OVS – SCL_SINK/SDA_SINK output voltage select
VSADJ	51	I	TMDS compliant voltage swing control
Vcc	1, 9, 15, 19 36, 42, 50, 55, 61 69, 75, 83, 89, 93 101, 107, 111, 119, 125		Power supply
GND	6, 12, 18, 33, 39, 45, 52, 58, 64 70, 80, 86, 92 98, 104, 110, 116, 122, 128		Ground

## EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



### ORDERING INFORMATION<sup>(1)</sup>

PART NUMBER	PART MARKING	PACKAGE
TMDS442PNP	TMDS442	128-PIN TQPF
TMDS442PNPR	TMDS442	128-PIN TQPF Tape/Reel

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at [www.ti.com](http://www.ti.com).

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			UNIT	
V <sub>CC</sub> Supply voltage range <sup>(2)</sup>			−0.5 V to 4 V	
Voltage range	Aim*, Bim		2.5 V to 4 V	
	Yjm, Zjm, , Vsadjj, HPDi, 5V_SINKj, LC_SCL, LC_SDA, LC_A0, LC_A1, GE, GPIO		−0.5V to 4 V	
	SCLi, SCL_SINKj, SDAi, SDA_SINKj, HPD_SINKj, 5V_PWRi		−0.5 V to 6 V	
Electrostatic discharge	Human body model <sup>(3)</sup>		Aim, Bim	±6 kV
			All pins	±5 kV
	Charged-device model <sup>(4)</sup> (all pins)		±1500 V	
	Machine model <sup>(5)</sup> (all pins)		±200 V	
Continuous power dissipation			See Dissipation Rating Table	

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.
- (3) Tested in accordance with JEDEC Standard 22, Test Method A114-B
- (4) Tested in accordance with JEDEC Standard 22, Test Method C101-A
- (5) Tested in accordance with JEDEC Standard 22, Test Method A115-A

## DISSIPATION RATINGS

PACKAGE	PCB JEDEC STANDARD	$T_A \leq 25^\circ\text{C}$	DERATING FACTOR <sup>(1)</sup> ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING
128-TQFP PNP	Low-K <sup>(2)</sup>	2129.47 mW	21.2947 mW/°C	1171.20 mW
128-TQFP PNP	High-K <sup>(3)</sup>	4308.48 mW	43.0848 mW/°C	2369.66 mW

- (1) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.
- (2) In accordance with the Low-K thermal metric definitions of EIA/JESD51-3
- (3) In accordance with the High-K thermal metric definitions of EIA/JESD51-7

## THERMAL CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JB}$ Junction-to-board thermal resistance			7.86		°C/W
$R_{\theta JC}$ Junction- to-case thermal resistance			19.5		°C/W
$P_D$ Device power dissipation	$V_{IH} = V_{CC}$ , $V_{IL} = V_{CC} - 0.6\text{ V}$ , $R_T = 50\ \Omega$ , $AV_{CC} = 3.3\text{ V}$ , $V_{CC} = 3.6\text{ V}$ , $R_{VSADJ} = 4.6\text{ k}\Omega$ , PRE = Low or high Ai/Bi(2:4) = 1.65 Gbps HDMI data pattern, Ai/Bi(1) = 165 MHz clock		1431		mW

## RECOMMENDED OPERATING CONDITIONS

	MIN	NOM	MAX	UNIT
$V_{CC}$ Supply voltage	3	3.3	3.6	V
$T_A$ Operating free-air temperature	0		70	°C
<b>TMDS DIFFERENTIAL PINS (A/B)</b>				
$V_{IC}$ Input common mode voltage	$V_{CC}-400$		$V_{CC}+10$	mV
$V_{ID}$ Receiver peak-to-peak differential input voltage	150		1560	mVp-p
$R_{VSADJ}$ Resistor for TMDS compliant voltage swing range	4.6	4.64	4.68	k $\Omega$
$AV_{CC}$ TMDS Output termination voltage, see <a href="#">Figure 3</a>	3	3.3	3.6	V
$R_T$ Termination resistance, see <a href="#">Figure 3</a>	45	50	55	$\Omega$
Signaling rate	0		2.25	Gbps
<b>CONTROL PINS (LC_A0, LC_A1, GE, GPIO)</b>				
$V_{IH}$ LVTTTL High-level input voltage	2		$V_{CC}$	V

## RECOMMENDED OPERATING CONDITIONS (continued)

		MIN	NOM	MAX	UNIT
V <sub>IL</sub>	LVTTL Low-level input voltage	GND		0.8	V
<b>CONTROL PINS (OVS)</b>					
V <sub>IH</sub>	LVTTL High-level input voltage	3		3.6	V
V <sub>IL</sub>	LVTTL Low-level input voltage	-0.5		0.5	V
<b>STATUS PINS (HPD_SINK, 5V_PWR)</b>					
V <sub>IH</sub>	High-level input voltage	2		5.3	V
V <sub>IL</sub>	Low-level input voltage	GND		0.8	V
<b>DDC I/O PINS (SCL_SINK, SDA_SINK)</b>					
V <sub>IH</sub>	High-level input voltage	0.7V <sub>CC</sub>		5.5	V
V <sub>IL</sub>	Low-level input voltage	-0.5		0.3V <sub>CC</sub>	V
V <sub>ILC</sub>	Low-level input voltage contention <sup>(1)</sup>	-0.5		0.4	V
<b>DDC I/O PINS (SCL, SDA)</b>					
V <sub>IH</sub>	High-level input voltage	2.1		5.5	V
V <sub>IL</sub>	Low-level input voltage	-0.5		1.5	V
<b>LOCAL I<sup>2</sup>C PINS (LC_SCL, LC_SDA)</b>					
V <sub>IH</sub>	High-level input voltage	0.7V <sub>CC</sub>		V <sub>CC</sub>	V
V <sub>IL</sub>	Low-level input voltage	-0.5		0.3V <sub>CC</sub>	V

(1) V<sub>IL</sub> specification is for the first low level seen by the SCL\_SINK/SDA\_SINK lines. V<sub>ILC</sub> is for the second and subsequent low levels seen by the SCL\_SINK/SDA\_SINK lines.

## ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
I <sub>CC</sub>	Supply current V <sub>IH</sub> = V <sub>CC</sub> , V <sub>IL</sub> = V <sub>CC</sub> - 0.4 V, R <sub>T</sub> = 50 Ω, AV <sub>CC</sub> = 3.3 V, Ai/Bi(2:4) = 1.65-Gbps HDMI data pattern, Ai/Bi(1) = 165-MHz Pixel clock		250	412 <sup>(2)</sup>	mA
P <sub>D</sub>	Power dissipation V <sub>IH</sub> = V <sub>CC</sub> , V <sub>IL</sub> = V <sub>CC</sub> - 0.4 V, R <sub>T</sub> = 50 Ω, AV <sub>CC</sub> = 3.3 V, Ai/Bi(2:4) = 1.65-Gbps HDMI data pattern, Ai/Bi(1) = 165-MHz Pixel clock		640	1344 <sup>(2)</sup>	mW
<b>TMDS DIFFERENTIAL PINS (A/B, Y/Z)</b>					
V <sub>OH</sub>	Single-ended high-level output voltage	AV <sub>CC</sub> -10		AV <sub>CC</sub> +10	mV
V <sub>OL</sub>	Single-ended low-level output voltage	AV <sub>CC</sub> -600		AV <sub>CC</sub> -400	mV
V <sub>swing</sub>	Single-ended output swing voltage	400		600	mV
V <sub>OD(O)</sub>	Overshoot of output differential voltage			15%	2× V <sub>swing</sub>
V <sub>OD(U)</sub>	Undershoot of output differential voltage			25%	2× V <sub>swing</sub>
ΔV <sub>OC(SS)</sub>	Change in steady-state common-mode output voltage between logic states			5	mV
I <sub>O(OFF)</sub>	Single-ended standby output current 0 V ≤ V <sub>CC</sub> ≤ 1.5 V, AV <sub>CC</sub> = 3.3 V, R <sub>T</sub> = 50 Ω	-10		10	μA
V <sub>OD(pp)</sub>	Peak-to-peak output differential voltage	800		1200	mVp-p
V <sub>ODE(SS)</sub>	Steady state output differential voltage with de-emphasis See Figure 5, PRE = High, AV <sub>CC</sub> = 3.3 V, R <sub>T</sub> = 50 Ω	560		840	
I <sub>(OS)</sub>	Short circuit output current See Figure 6	PRE = Low		12	mA
		PRE = High		15	
V <sub>I(open)</sub>	Single-ended input voltage under high impedance input or open input I <sub>I</sub> = 10 μA	V <sub>CC</sub> -10		V <sub>CC</sub> +10	mV
R <sub>INT</sub>	Input termination resistance V <sub>IN</sub> = 2.9 V	45	50	55	Ω
<b>STATUS PINS (HPD_SINK, 5V_PWR)</b>					

(1) All typical values are at 25°C and with a 3.3-V supply.

(2) The maximum rating is characterized under 3.6 V V<sub>CC</sub>.



## ELECTRICAL CHARACTERISTICS (continued)

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT
I <sub>IH</sub>	High-level digital input current	V <sub>IH</sub> = 5.3 V		-150		150	μA
		V <sub>IH</sub> = 2 V or V <sub>CC</sub>		-85		85	
I <sub>IL</sub>	Low-level digital input current	V <sub>IL</sub> = GND or 0.8 V		-20		20	μA
STATUS PINS (HPD, 5V_SINK)							
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -4 mA		2.4		V <sub>CC</sub>	V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 4 mA		GND		0.4	V
CONTROL PINS (LC_A0, LC_A1, GE, GPIO)							
I <sub>IH</sub>	High-level digital input current	V <sub>IH</sub> = 2 V or V <sub>CC</sub>		-10		10	μA
I <sub>IL</sub>	Low-level digital input current	V <sub>IL</sub> = GND or 0.8 V		-10		10	μA
C <sub>I</sub>	Input capacitance	V <sub>I</sub> = GND or V <sub>CC</sub>				10	pF
DDC I/O PINS (SCL_SINK, SDA_SINK)							
I <sub>Ikg</sub>	Input leakage current	V <sub>I</sub> = 5.5 V		-50		50	μA
		V <sub>I</sub> = V <sub>CC</sub>		-10		10	
I <sub>OH</sub>	High-level output current	V <sub>O</sub> = 3.6 V		-10		10	μA
I <sub>IL</sub>	Low-level input current	V <sub>IL</sub> = GND		-40		40	μA
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 400 μA or 4 mA	OVS = NC	470		620	V
			OVS = GND	620		775	
			OVS = V <sub>CC</sub>	775		950	
V <sub>OL</sub> -V <sub>ILC</sub>	Low-level input voltage below output low-level voltage level	Ensured by design	OVS = NC		70		mV
			OVS = GND		240		
			OVS = V <sub>CC</sub>		420		
C <sub>IO</sub>	Input/output capacitance	V <sub>I</sub> = 5.0 V or 0 V, Freq = 100 kHz				25	pF
		V <sub>I</sub> = 3.0 V or 0 V, Freq = 100 kHz				10	
DDC I/O PINS (SCL, SDA) AND LOCAL I <sup>2</sup> C PINS (LC_SCL, LC_SDA)							
I <sub>Ikg</sub>	Input leakage current	V <sub>I</sub> = 5.5 V		-50		50	μA
		V <sub>I</sub> = V <sub>CC</sub>		-10		10	
I <sub>OH</sub>	High-level output current	V <sub>O</sub> = 3.6 V		-10		10	μA
I <sub>IL</sub>	Low-level input current	V <sub>IL</sub> = GND		-10		10	μA
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 4 mA				0.2	V
C <sub>I</sub>	Input capacitance	V <sub>I</sub> = 5.0 V or 0 V, Freq = 100 kHz				25	pF
		V <sub>I</sub> = 3.0 V or 0 V, Freq = 100 kHz				10	

## SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
TMDS DIFFERENTIAL PINS (Y/Z)						
t <sub>PLH</sub>	Propagation delay time, low-to-high-level output	See Figure 4, AV <sub>CC</sub> = 3.3 V, R <sub>T</sub> = 50 Ω	250		800	ps
t <sub>PHL</sub>	Propagation delay time, high-to-low-level output		250		800	ps
t <sub>r</sub>	Differential output signal rise time (20% - 80%)		80		240	ps
t <sub>f</sub>	Differential output signal fall time (20% - 80%)		80		240	ps
t <sub>sk(p)</sub>	Pulse skew ( $ t_{PHL} - t_{PLH} $ ) <sup>(2)</sup>				50	ps
t <sub>sk(D)</sub>	Intra-pair differential skew, see Figure 7				75	ps
t <sub>sk(o)</sub>	Inter-pair channel-to-channel output skew <sup>(3)</sup>				150	ps
t <sub>sk(bb)</sub>	Bank-to-bank skew				300	ps
t <sub>sk(pp)</sub>	Part-to-part skew <sup>(4)</sup>				1	ns
t <sub>en</sub>	Enable time	See Figure 8			20	ns
t <sub>dis</sub>	Disable time				20	ns
t <sub>sx</sub>	TMDS Switch time			20	ns	
t <sub>jit(pp)</sub>	Peak-to-peak output jitter from Y/Z(1), residual jitter	See Figure 9, Ai/Bi(1) = 165-MHz clock, Ai/Bi(2:4) = 1.65-Gbps HDMI pattern, PRE = low Input: 5m 28AWG HDMI cable, Output: 3-Inch 8-mil trace width		10	30	ps
t <sub>jit(pp)</sub>	Peak-to-peak output jitter from Y/Z(2:4), residual jitter			48	74	ps
t <sub>jit(pp)</sub>	Peak-to-peak output jitter from Y/Z(1), residual jitter	See Figure 9, Ai/Bi(1) = 225-MHz clock, Ai/Bi(2:4) = 2.25-Gbps HDMI pattern, PRE = low Input: 5m 28AWG HDMI cable, Output: 3-Inch 8-mil trace width		18	33	ps
t <sub>jit(pp)</sub>	Peak-to-peak output jitter from Y/Z(2:4), residual jitter			56	71	ps
CONTROL AND STATUS PINS (HPD_SINK, HPD, 5V_PWR, 5V_SINK)						
t <sub>pd(HPD)</sub>	Propagation delay time	See Figure 8 C <sub>L</sub> = 10 pF, C <sub>L(DDC)</sub> = 100 pF			15	ns
t <sub>pd(5V)</sub>	Propagation delay time				15	ns
t <sub>sx(HPD)</sub>	HPD Switch time				15	ns
t <sub>sx(5V)</sub>	5-V Power switch time				15	ns
t <sub>sx</sub>	DDC Switch time				1	μs
DDC I/O PINS (SCL, SCL_SINK, SDA, SDA_SINK)						
t <sub>PLH</sub>	Propagation delay time, low-to-high-level output SCL_SINK/SDA_SINK to SCL/SDA	See Figure 11, OVS = NC	204		459	ns
t <sub>PHL</sub>	Propagation delay time, high-to-low-level outputSCL_SINK/SDA_SINK to SCL/SDA		35		140	ns
t <sub>PLH</sub>	Propagation delay time, low-to-high-level output SCL/SDA to SCL_SINK/SDA_SINK		194		351	ns
t <sub>PHL</sub>	Propagation delay time, high-to-low-level output SCL/SDA to SCL_SINK/SDA_SINK		35		140	ns
t <sub>r</sub>	Output signal rise time, SCL_SINK/SDA_SINK		500		800	ns
t <sub>f</sub>	Output signal fall time, SCL_SINK/SDA_SINK		20		72	ns
t <sub>r</sub>	Output signal rise time, SCL/SDA		796		999	ns
t <sub>f</sub>	Output signal fall time, SCL/SDA		20		72	ns
t <sub>set</sub>	Enable to start condition		See Figure 12	100		
t <sub>hold</sub>	Enable after stop condition	100				ns

(1) All typical values are at 25°C and with a 3.3-V supply.

(2)  $t_{sk(p)}$  is the magnitude of the time difference between  $t_{PLH}$  and  $t_{PHL}$  of a specified terminal.

(3)  $t_{sk(o)}$  is the magnitude of the difference in propagation delay times between any specified terminals of channel 2 to 4 of a device when inputs are tied together.

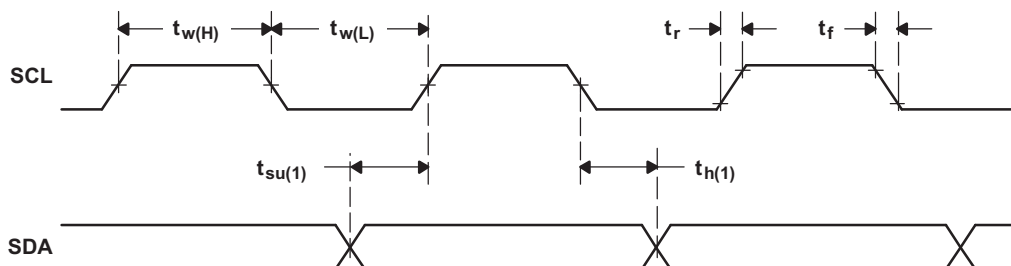
(4)  $t_{sk(pp)}$  is the magnitude of the difference in propagation delay times between any specified terminals of channel 2 to 4 of two devices, or between channel 1 of two devices, when both devices operate with the same source, the same supply voltages, at the same temperature, and have identical packages and test circuits.

**TIMING CHARACTERISTICS FOR LOCAL I<sup>2</sup>C INTERFACE (LC\_SCL, LC\_SDA, LC\_A0, LC\_A1)**

PARAMETER	STANDARD MODE		FAST MODE		UNIT
	MIN	MAX	MIN	MAX	
f <sub>SCL</sub> Clock frequency, SCL		100		400	kHz
t <sub>w(L)</sub> Clock low period, SCL low	4.7		1.3		μs
t <sub>w(H)</sub> Clock high period, SCL high	4		0.6		μs
t <sub>r</sub> Rise time, SCL and SDA		1000		300	μs
t <sub>f</sub> Fall time, SCL and SDA		300		300	μs
t <sub>su(1)</sub> Setup time, SDA to SCL	250		100		μs
t <sub>h(1)</sub> Hold time, SCL to SDA	0		0		μs
t <sub>(buf)</sub> BUS Free time between a STOP and START condition	4.7		1.3		μs
t <sub>su(2)</sub> Setup time, SCL to start condition	4.7		0.6		μs
t <sub>h(2)</sub> Hold time, start condition to SCL	4		0.6		μs
t <sub>su(3)</sub> Setup time, SCL to stop condition	4		0.6		μs
C <sub>b</sub> <sup>(1)</sup> Capacitive load for each bus line		400		400	pF

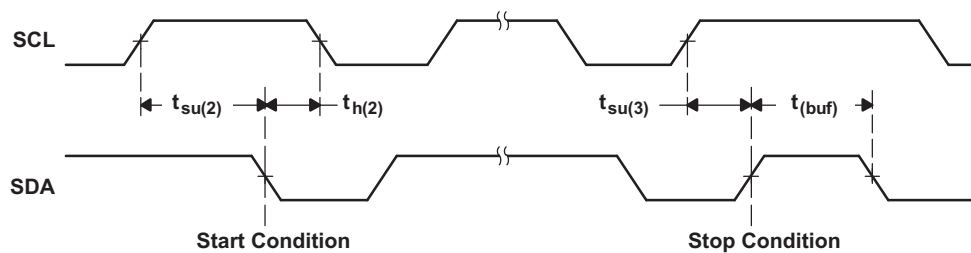
(1) C<sub>b</sub> is the total capacitance of one bus line in pF.

## PARAMETER MEASUREMENT INFORMATION

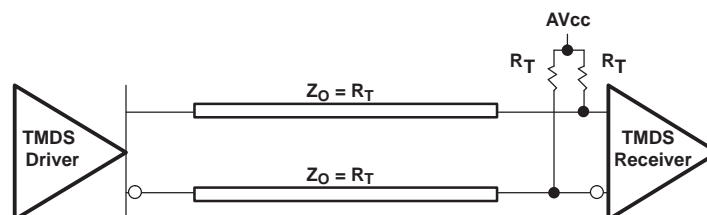


A.  $t_r$  and  $t_f$  are measured at 20% - 80% referred to  $V_{IHmin}$  and  $V_{ILmax}$  levels.

**Figure 1. SCL and SDA Timing**

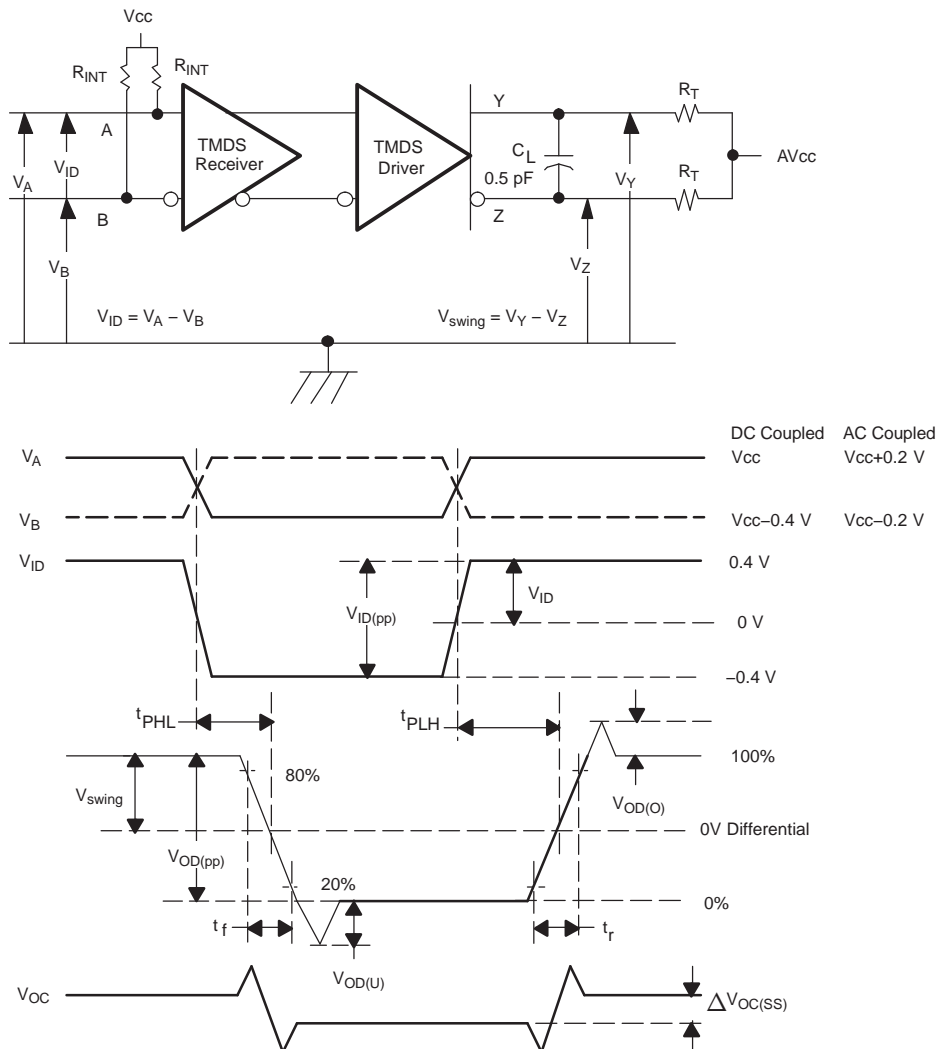


**Figure 2. Start and Stop Conditions**



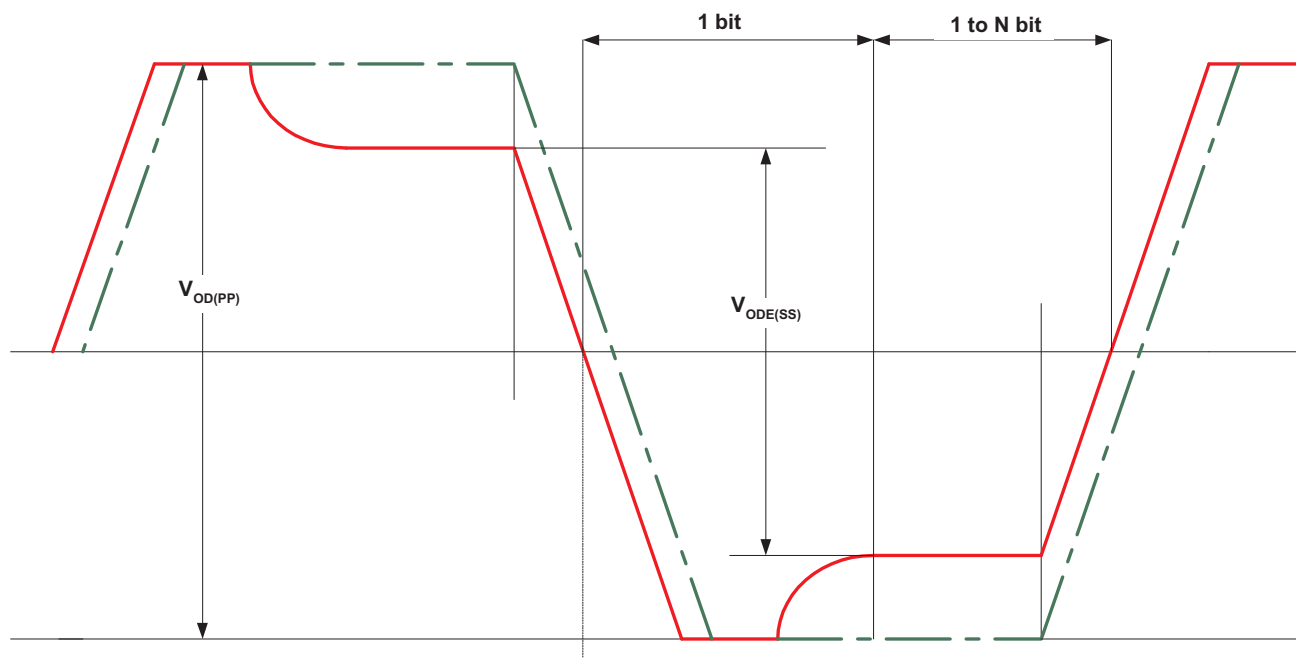
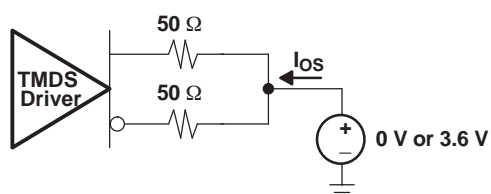
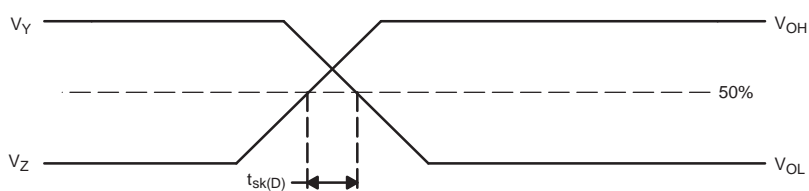
**Figure 3. Typical Termination for TMDS Output Driver**

## PARAMETER MEASUREMENT INFORMATION (continued)



NOTE: PRE = low. All input pulses are supplied by a generator having the following characteristics:  $t_r$  or  $t_f < 100$  ps, 100 MHz from Agilent 81250.  $C_L$  includes instrumentation and fixture capacitance within 0.06 m of the D.U.T. Measurement equipment provides a bandwidth of 20 GHz minimum.

Figure 4. TMDS Timing Test Circuit and Definitions

**PARAMETER MEASUREMENT INFORMATION (continued)****Figure 5. De-Emphasis Output Voltage Waveforms and Duration Measurement Definitions****Figure 6. Short Circuit Output Current Test Circuit****Figure 7. Definition of Intra-Pair Differential Skew**

## PARAMETER MEASUREMENT INFORMATION (continued)

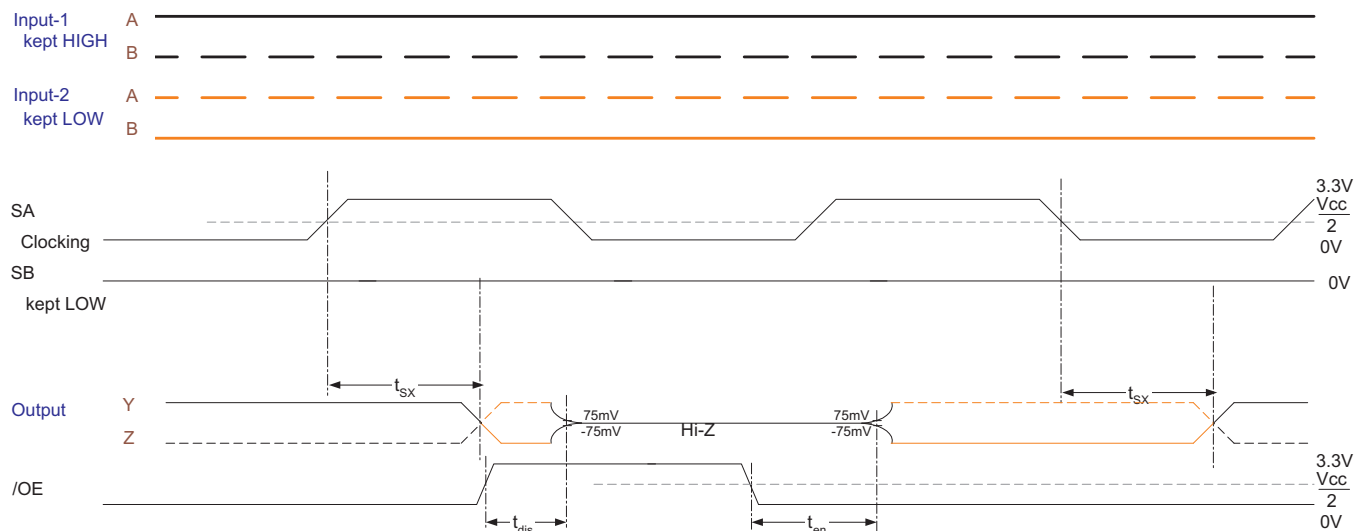
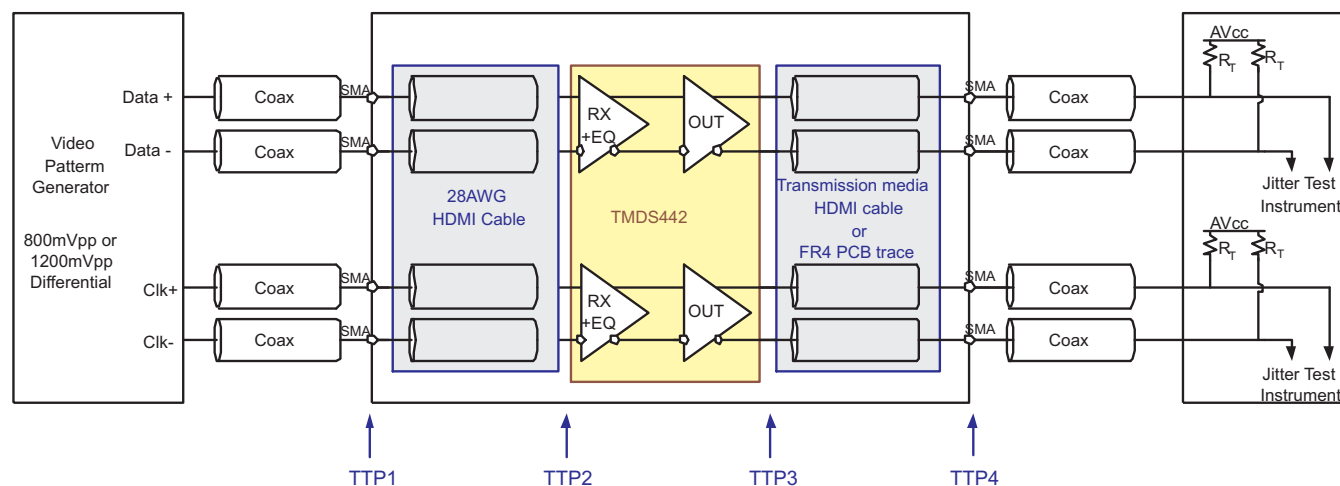
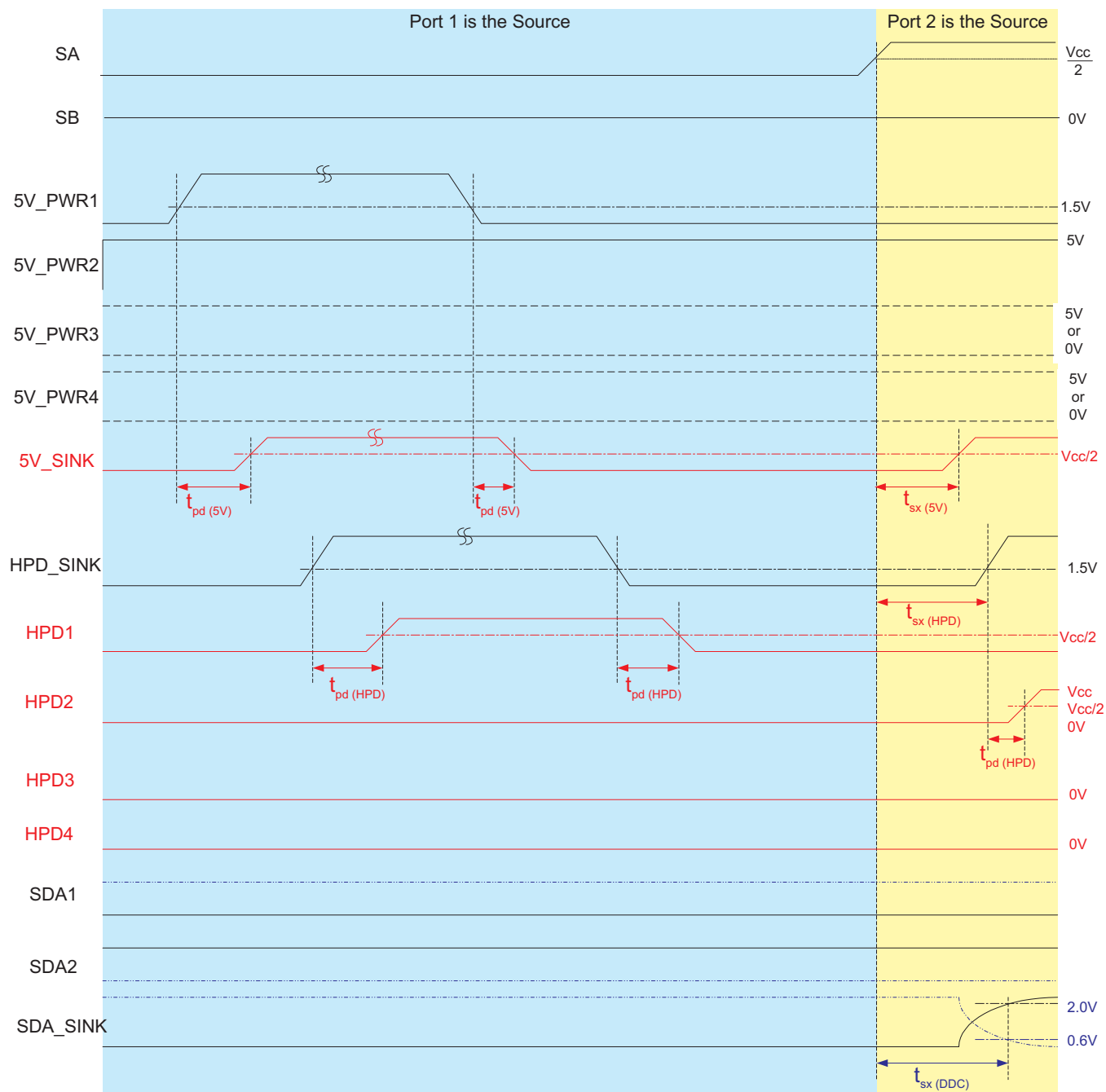


Figure 8. TMDS Outputs Control Timing Definitions



- All jitters are measured in BER of  $10^{-12}$
- The residual jitter reflects the total jitter measured at the TMDS442 output, TP3, subtract the total jitter from the signal generator, TP1
- The input cable length and the output transmission media are specified in the test conditions.

Figure 9. Jitter Test Circuit

**PARAMETER MEASUREMENT INFORMATION (continued)****Figure 10. Post Switch Timing Definitions**



## PARAMETER MEASUREMENT INFORMATION (continued)

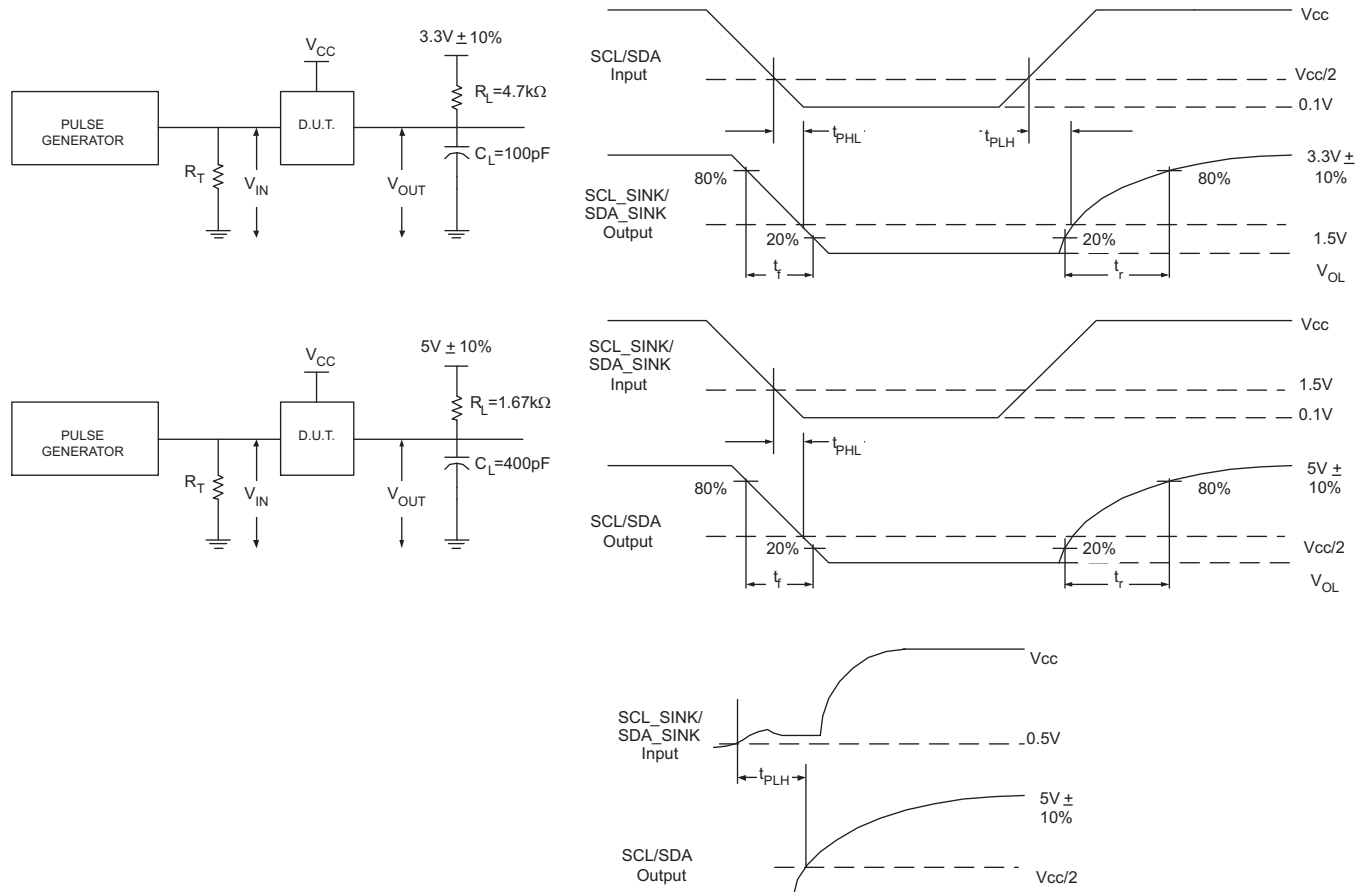


Figure 11. I²C Timing Test Circuit and Definition

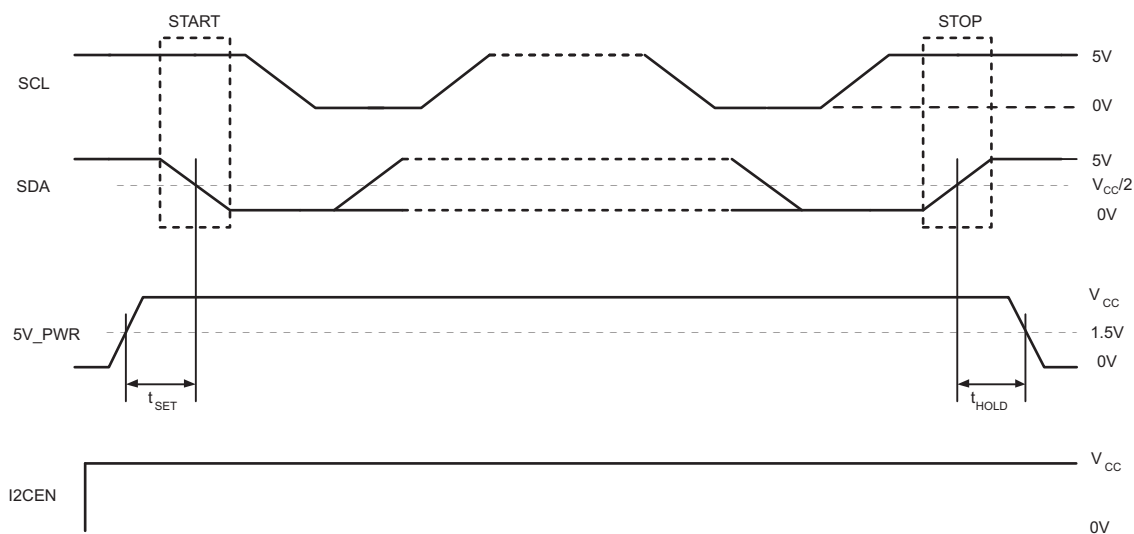
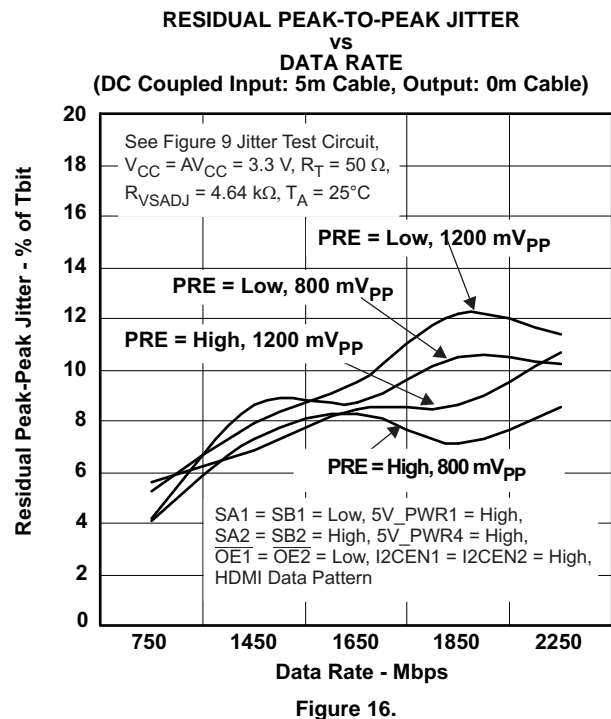
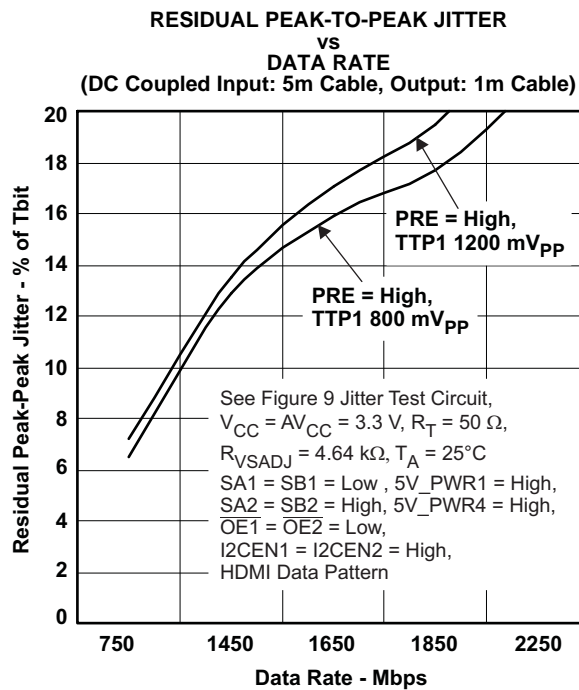
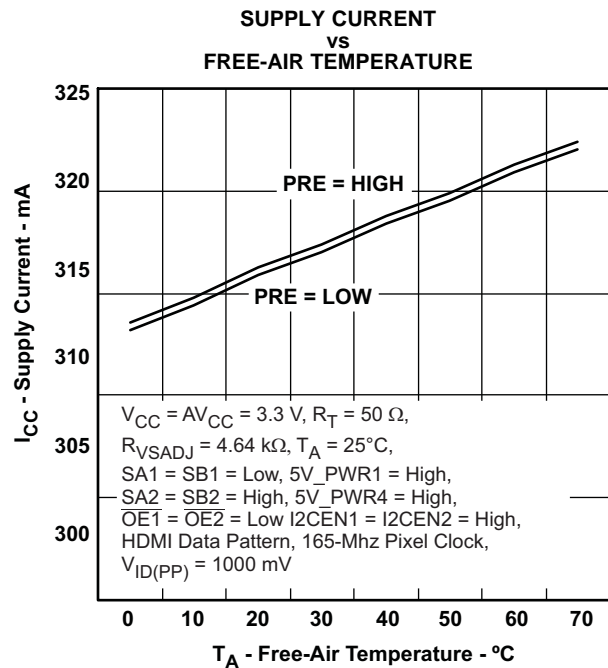
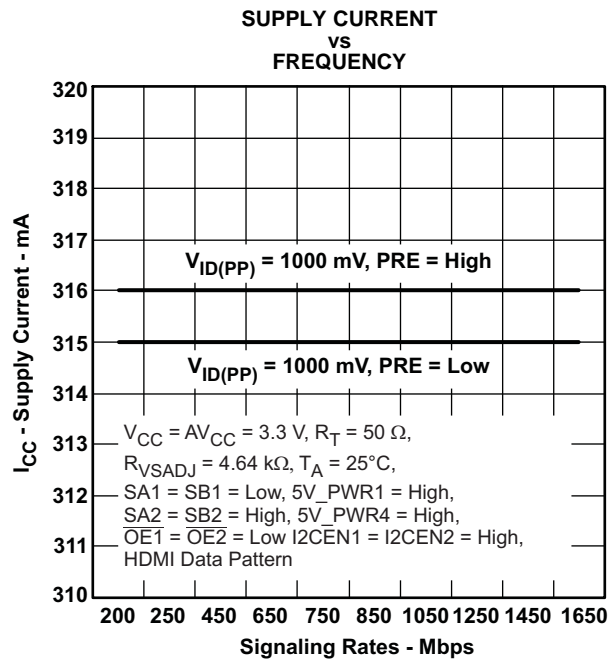


Figure 12. I²C Setup and Hold Definition

## TYPICAL CHARACTERISTICS



## TYPICAL CHARACTERISTICS (continued)

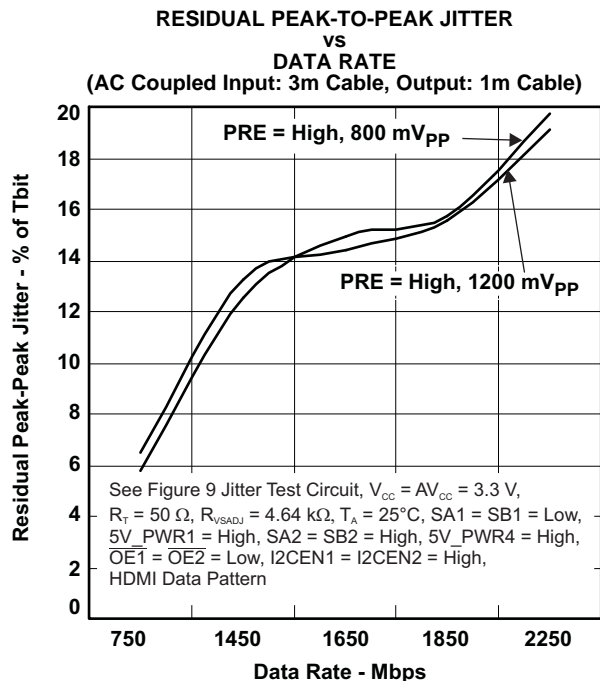


Figure 17.

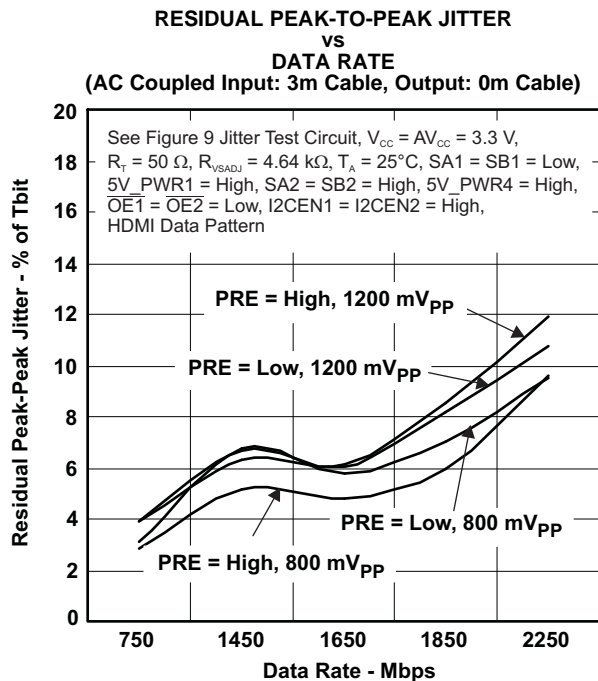


Figure 18.

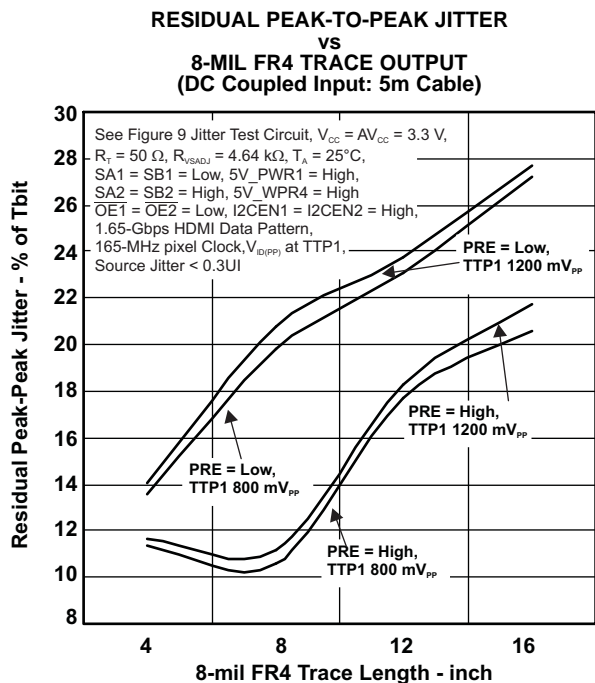


Figure 19.

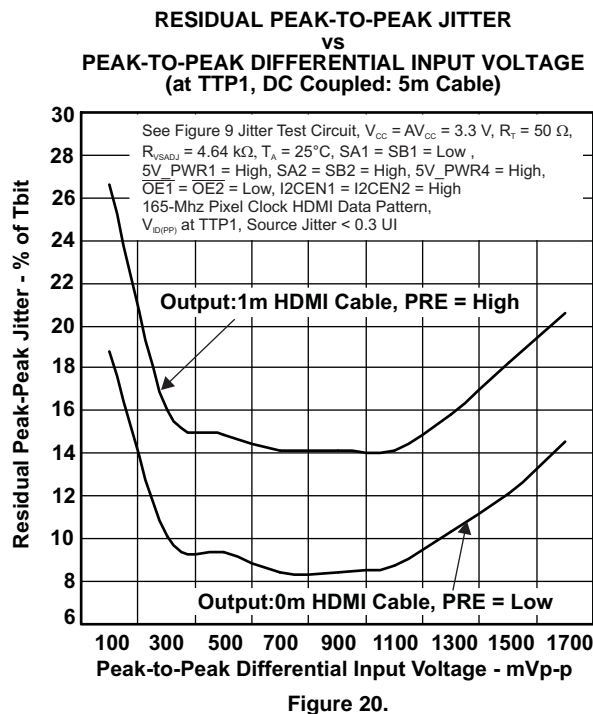


Figure 20.

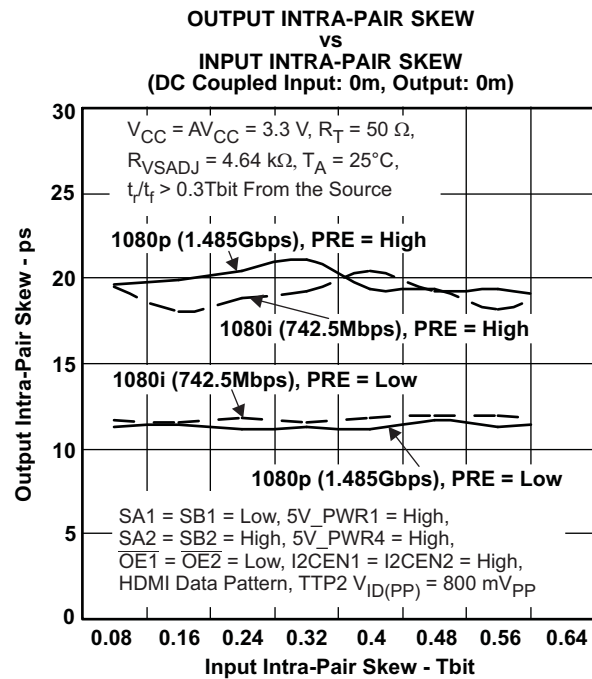
**TYPICAL CHARACTERISTICS (continued)**

Figure 21.

## TYPICAL CHARACTERISTICS (continued)

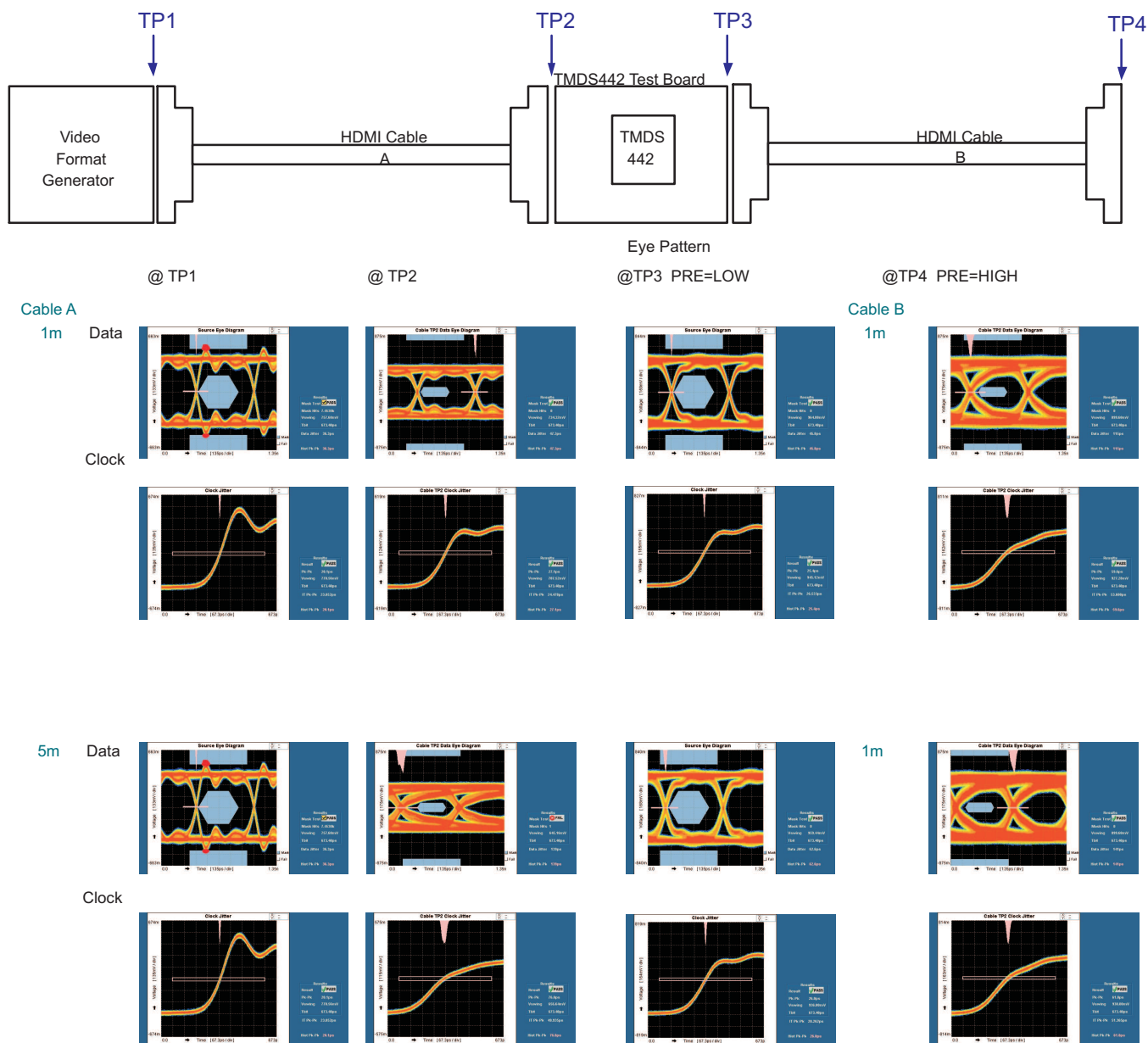


Figure 22. Eye Patterns at 148.5-MHz Pixel Clock

**DESCRIPTION****SOURCE SELECTION LOOKUP**

CONTROL REGISTER BITS				I/O SELECTED		HOT PLUG DETECT STATUS			
SB	SA	OE	I2CEN	Y/Z	SCL_SINK SDA_SINK	HPD1	HPD2	HPD3	HPD4
L	L	L	H	A1/B1	SCL1 SDA1	HPD_SINK	L	L	L
L	H	L	H	A2/B2	SCL2 SDA2	L	HPD_SINK	L	L
H	L	L	H	A3/B3	SCL3 SDA3	L	L	HPD_SINK	L
H	H	L	H	A4/B4	SCL4 SDA4	L	L	L	HPD_SINK
X	X	L	L	A/B	Z	HPD_SINK is transmitted to corresponding source port			
X	X	H	H	Z	SCL SDA	HPD_SINK is transmitted to corresponding source port			
X	X	H	L	Z	Z	HPD_SINK is transmitted to corresponding source port			

**SINK PRIORITY CONTROL**

(SA1 = SA2 = Low, SB1 = SB2 = Low, OE1 = OE2 = Low, I2CEN1 = I2CEN2 = High)

SINK PRIORITY	SINK PORT 1		SINK PORT 2		
SP	Y1/Z1	SCL_SINK1/SDA_SINK1	Y2/Z2	SCL_SINK2/SDA_SINK2	HPD1
L	A1/B1	SCL1/SDA1	A1/B1	Z	HPD_SINK1
H	A1/B1	Z	A1/B1	SCL1/SDA1	HPD_SINK2

**5V\_PWR STATUS**

(SA = Low, SB = Low, OE = Low, I2CEN = High)

CONTROL STATUS SOURCE PLUG IN STATUS			I/O SELECTED		HOT PLUG DETECT STATUS			
GE	5V_EN	5V_PWR1	Y/Z	SCL_SINK/SDA_SINK	HPD1	HPD2	HPD3	HPD4
L	H	H	A1/B1	SCL1/SDA1	HPD_SINK	L	L	L
L	H	L	Z	Z	L	L	L	L
L	L	X	A1/B1	SCL1/SDA1	HPD_SINK	L	L	L
H	X	H	A1/B1	SCL1/SDA1	HPD_SINK	L	L	L
H	X	L	Z	Z	L	L	L	L

**I<sup>2</sup>C POINTER REGISTER**

P7	P6	P5	P4	P3	P2	P1	P0
0	0	0	0	0	0	X	X

01, Sink port 1 configuration register

10, Sink port 2 configuration register

11, Source plug-in status register

Power up default is 0000 0011

**SINK PORT 1 CONFIGURATION REGISTER**

C7	C6	C5	C4	C3	C2	C1	C0
0	0	0	PRE1	I2CEN1	$\overline{OE1}$	SB1	SA1

Power up default is 0000 1000

**SINK PORT 2 CONFIGURATION REGISTER**

C7	C6	C5	C4	C3	C2	C1	C0
0	0	0	PRE2	I2CEN2	$\overline{OE2}$	SB2	SA2

Power up default is 0000 1001

**SOURCE PLUG-IN STATUS REGISTER**

S7	S6	S5	S4	S3	S2	S1	S0
0	0	SP	5V_EN	5V_PWR4	5V_PWR3	5V_PWR2	5V_PWR1

Power up default is 0001 0000

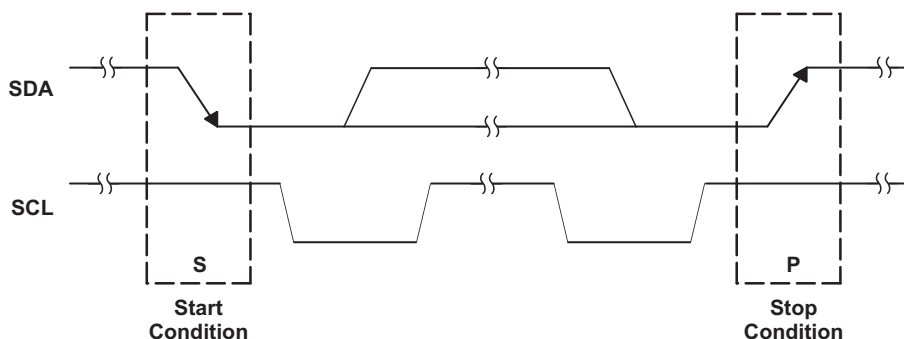
## APPLICATION INFORMATION

### I<sup>2</sup>C Interface Notes

The I<sup>2</sup>C interface is used to access the internal registers of the TMDS442. I<sup>2</sup>C is a two-wire serial interface developed by Philips Semiconductor (see I<sup>2</sup>C-Bus Specification, Version 2.1, January 2000). The bus consists of a data line (SDA) and a clock line (SCL) with pull-up structures. When the bus is idle, both SDA and SCL lines are pulled high. All the I<sup>2</sup>C compatible devices connect to the I<sup>2</sup>C bus through open drain I/O pins, SDA and SCL. A master device, usually a microcontroller or a digital signal processor, controls the bus. The master is responsible for generating the SCL signal and device addresses. The master also generates specific conditions that indicate the START and STOP of data transfer. A slave device receives and/or transmits data on the bus under control of the master device. The TMDS442 works as a slave and supports the standard mode transfer (100 kbps) and fast mode transfer (400 kbps) as defined in the I<sup>2</sup>C-Bus Specification. The TMDS442 has been tested to be fully functional with the high-speed mode (3.4 Mbps) but is not ensured at this time.

The basic I<sup>2</sup>C start and stop access cycles are shown in [Figure 23](#). The basic access cycle consists of the following:

- A start condition
- A slave address cycle
- Any number of data cycles
- A stop condition



**Figure 23. I<sup>2</sup>C Start and Stop Conditions**

### General I<sup>2</sup>C Protocol

- The master initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in [Figure 23](#). All I<sup>2</sup>C-compatible devices should recognize a start condition.
- The master then generates the SCL pulses and transmits the 7-bit address and the read/write direction bit R/W on the SDA line. During all transmissions, the master ensures that data is valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse (see [Figure 23](#)). All devices recognize the address sent by the master and compare it to their internal fixed addresses. Only the slave device with a matching address generates an acknowledge (see [Figure 25](#)) by pulling the SDA line low during the entire high period of the ninth SCL cycle. On detecting this acknowledge, the master knows that a communication link with a slave has been established.
- The master generates further SCL cycles to either transmit data to the slave (R/W bit 1) or receive data from the slave (R/W bit 0). In either case, the receiver needs to acknowledge the data sent by the transmitter. So an acknowledge signal can either be generated by the master or by the slave, depending on which one is the receiver. The 9-bit valid data sequences consisting of 8-bit data and 1-bit acknowledge can continue as long as necessary (see [Figure 26](#)).
- To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low to high while the SCL line is high (see [Figure 23](#)). This releases the bus and stops the communication link with the addressed slave. All I<sup>2</sup>C compatible devices must recognize the stop condition. Upon the receipt of a stop condition, all devices know that the bus is released, and they wait for a start condition followed by a matching address.



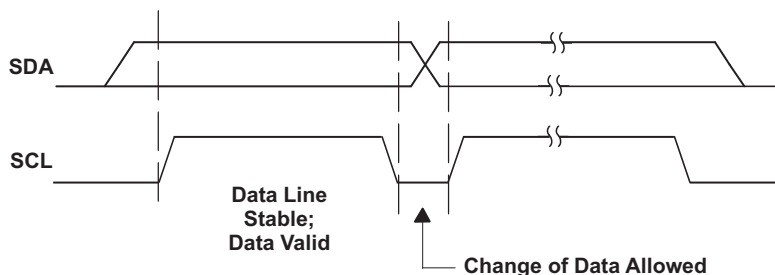


Figure 24. I²C Bit Transfer

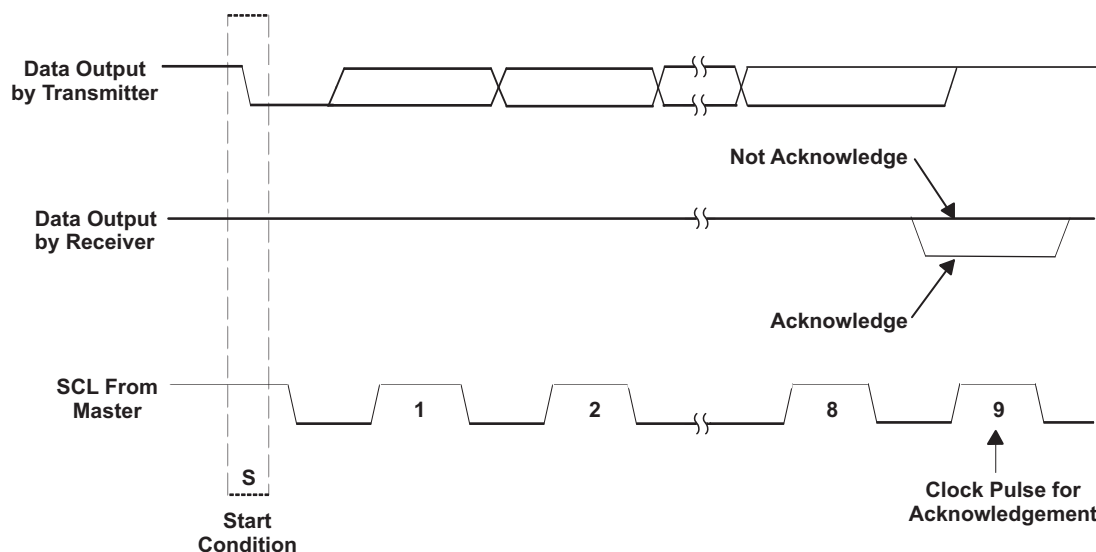


Figure 25. I²C Acknowledge

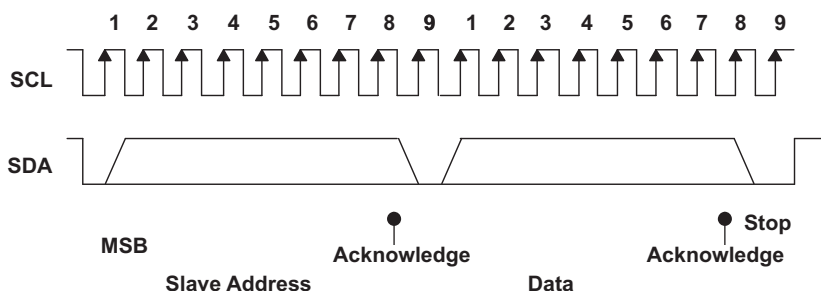


Figure 26. I²C Address and Data Cycles

During a write cycle, the transmitting device must not drive the SDA signal line during the acknowledge cycle so that the receiving device may drive the SDA signal low. After each byte transfer following the address byte, the receiving device will pull the SDA line low for one SCL clock cycle. A stop condition will be initiated by the transmitting device after the last byte is transferred. An example of a write cycle can be found in [Figure 27](#) and [Figure 28](#). Note that the TMDS442 does not allow multiple write transfers to occur. See Example – Writing to the TMDS442 section for more information.

During a read cycle, the slave receiver will acknowledge the initial address byte if it decodes the address as its address. Following this initial acknowledge by the slave, the master device becomes a receiver and

acknowledges data bytes sent by the slave. When the master has received all of the requested data bytes from the slave, the not acknowledge (A) condition is initiated by the master by keeping the SDA signal high just before it asserts the stop (P) condition. This sequence terminates a read cycle as shown in Figure 29 and Figure 30. Note that the TMDS442 does not allow multiple read transfers to occur. See Example – Reading from the TMDS442 section for more information.

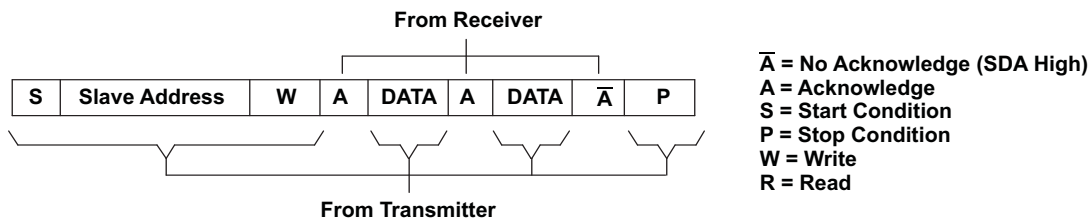
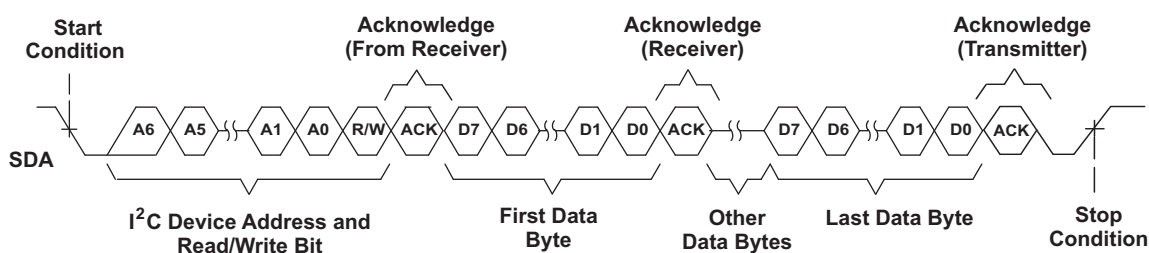
Figure 27. I<sup>2</sup>C Write Cycle

Figure 28. Multiple Byte Write Transfer

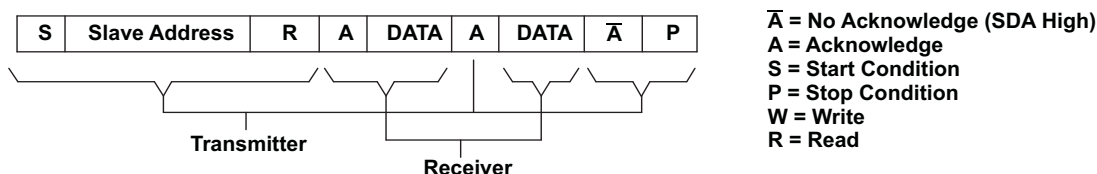
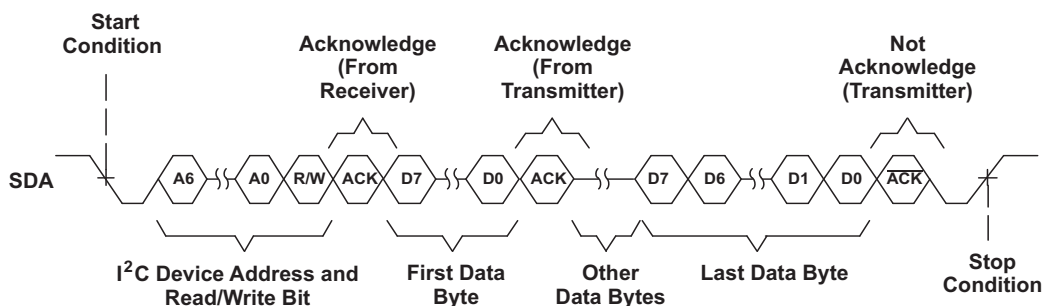
Figure 29. I<sup>2</sup>C Read Cycle

Figure 30. Multiple Byte Read Transfer

## Slave Address

Both SDA and SCL must be connected to a positive supply voltage via a pull-up resistor. These resistors should comply with the I<sup>2</sup>C specification that ranges from 2 kΩ to 19 kΩ. When the bus is free, both lines are high. The address byte is the first byte received following the START condition from the master device. The first 5 Bits (MSBs) of the address are factory preset to 01011. The next two bits of the TMDS442 address are controlled by

the logic levels appearing on the I<sup>2</sup>C-A1 and I<sup>2</sup>C-A0 pins. The I<sup>2</sup>C-A1 and I<sup>2</sup>C-A0 address inputs can be connected to V<sub>CC</sub> for logic 1, GND for logic 0, or can be actively driven by TTL/CMOS logic levels. The device addresses are set by the state of these pins and are not latched. Thus a dynamic address control system could be utilized to incorporate several devices on the same system. Up to four TMDS442 devices can be connected to the same I<sup>2</sup>C-Bus without requiring additional glue logic. [Table 1](#) lists the possible addresses for the TMDS442.

**Table 1. TMDS442 Slave Addresses**

FIXED ADDRESSES					SELECTABLE WITH ADDRESS PINS		READ/WRITE BIT
BIT 7 (MSB)	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2 (A1)	BIT 1 (A0)	BIT 0 (R/W)
0	1	0	1	1	0	0	0
0	1	0	1	1	0	0	1
0	1	0	1	1	0	1	0
0	1	0	1	1	0	1	1
0	1	0	1	1	1	0	0
0	1	0	1	1	1	0	1
0	1	0	1	1	1	1	0
0	1	0	1	1	1	1	1

### Sink Port Selection Register and Source Plug-In Status Register Description (Sub-Address)

The TMDS442 operates using only a single byte transfer protocol similar to [Figure 27](#) and [Figure 29](#). The internal sub-address registers and the functionality of each can be found in [Table 2](#). When writing to the device, it is required to send one byte of data to the corresponding internal sub-address. If control of two sink ports and source plug-in status is desired, then the master will have to cycle through the sub-addresses (sink ports) one at a time as illustrated in the Example – Writing to the TMDS442 section for the proper procedure of writing to the TMDS442.

During a read cycle, the TMDS442 sends the data in its selected sub-address in a single transfer to the master device requesting the information. See the Example – Reading from the TMDS442 section of this document for the proper procedure on reading from the TMDS442. Upon power up, the TMDS442 registers are in a default value, 0000 0011.

**Table 2. TMDS442 Sink Port and Source Plug-In Status Registers Selection**

REGISTER NAME	BIT ADDRESS (b <sub>7</sub> b <sub>6</sub> b <sub>5</sub> ...b <sub>0</sub> )
Sink port 1	0000 0001
Sink port 2	0000 0010
Source plug-in status	0000 0011

### Sink Port Register Bit Descriptions

Each bit of the first two sub-addresses, sink port 1 and port 2 control registers, allows the user to individually control the functionality of the TMDS442. The benefit of this process allows the user to control the functionality of each sink port independent of the other sink port. The bit description is decoded in [Table 3](#).

**Table 3. TMDS442 Sink Port Register Bit Decoder**

BIT	FUNCTION	BIT VALUES	RESULT
7, 6, 5	Reserved	000	Default value
4	PRE	0	3dB De-emphasis off
		1	3dB De-emphasis on
3	I <sup>2</sup> CEN	0	Sink side I <sup>2</sup> C buffer is disabled (Hi-Z)
		1	Sink side I <sup>2</sup> C buffer is enabled
2	OE	0	Sink side TMDS on
		1	Sink side TMDS off (Hi-Z)

**Table 3. TMDS442 Sink Port Register Bit Decoder (continued)**

BIT	FUNCTION	BIT VALUES	RESULT
1, 0	SB SA	00	Source port 1 select
		01	Source port 2 select
		10	Source port 3 select
		11	Source port 4 select

Bits 7 (MSB), 6 and 5 – Reserved bits without function.

Bit 4 – Controls the TMDS output differential voltage.

Bit 3 – Controls the status of DDC interface, SCL\_SINK and SDA\_SINK.

Bit 2 – Controls the status of TMDS interface, Y/Z.

Bits 1, and 0 (LSB) – Selects the source input of the TMDS442.

The 5-V plug in status can be read through each bit of the sub-address (source plug-in status) status register. Each bit of the third sub-address, source plug-in status registers, allows the user to read the cable plug-in status based on the appearance of a valid +5-V power signal from each source input port. The bit description is decoded in [Table 4](#).

**Table 4. TMDS442 Source Plug-In Status Register Bit Decoder**

BIT	FUNCTION	BIT VALUES	RESULT
7, 6	Reserved	0 0	Default value
5	SP	0	Sink port1 is the main display when the same source is selected by both sinks
		1	Sink port2 is the main display when the same source is selected by both sinks
4	5V_EN	0	TMDS output status is not controlled by the corresponding +5-V power signal
		1	TMDS output status is controlled by the corresponding +5-V power signal
3	5V_PWR4	0	Source side I <sup>2</sup> C buffer is disabled (Hi-Z) When source port 4 is selected by sink, TMDS is Hi-Z
		1	Source side I <sup>2</sup> C buffer is enabled When source port 4 is selected by sink, TMDS is under the control of $\overline{OE}$
2	5V_PWR3	0	Source side I <sup>2</sup> C buffer is disabled (Hi-Z)
		1	When source port 3 is selected by sink, TMDS is Hi-Z
1	5V_PWR2	0	Source side I <sup>2</sup> C buffer is disabled (Hi-Z) When source port 2 is selected by sink, TMDS is Hi-Z
		1	Source side I <sup>2</sup> C buffer is enabled When source port 2 is selected by sink, TMDS is under the control of $\overline{OE}$
0	5V_PWR1	0	Source side I <sup>2</sup> C buffer is disabled (Hi-Z) When source port 1 is selected by sink, TMDS is Hi-Z
		1	Source side I <sup>2</sup> C buffer is enabled When source port 1 is selected by sink, TMDS is under the control of $\overline{OE}$

### Example - Writing to the TMDS442

The proper way to write to the TMDS442 is illustrated as follows:

An I<sup>2</sup>C master initiates a write operation to the TMDS442 by generating a start condition (S) followed by the TMDS442 I<sup>2</sup>C address (as shown below), in MSB first bit order, followed by a 0 to indicate a write cycle. After receiving an acknowledge from the TMDS442, the master presents the sub-address (sink port) it wants to write consisting of one byte of data, MSB first. The TMDS442 acknowledges the byte after completion of the transfer. Finally the master presents the data it wants to write to the register (sink port) and the TMDS442 acknowledges the byte. The I<sup>2</sup>C master then terminates the write operation by generating a stop condition (P). Note that the TMDS442 does not support multi-byte transfers. To write to both sink ports – or registers - this procedure must be repeated for each register one series at a time (i.e. repeat steps 1 through 8 for each sink port).

<b>STEP 1</b>	<b>0</b>
I <sup>2</sup> C Start (Master)	S

<b>STEP 2</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
I <sup>2</sup> C General Address (Master)	0	1	0	1	1	X	X	0

Where each X logic state is defined by I2C-A1 and I2C-A0 pins being tied to either Vs+ or GND.

<b>STEP 3</b>	<b>9</b>
I <sup>2</sup> C Acknowledge (Slave)	A

<b>STEP 4</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
I <sup>2</sup> C Write Sink Port Address (Master)	0	0	0	0	0	0	Addr	Addr

Where Addr is determined by the values shown in [Table 2](#).

<b>STEP 5</b>	<b>9</b>
I <sup>2</sup> C Acknowledge (Slave)	A

<b>STEP 6</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
I <sup>2</sup> C Write Data (Master)	Data	Data	Data	Data	Data	Data	Data	Data

Where Data is determined by the values shown in [Table 3](#).

<b>STEP 7</b>	<b>9</b>
I <sup>2</sup> C Acknowledge (Slave)	A

<b>STEP 8</b>	<b>0</b>
I <sup>2</sup> C Stop (Master)	P

For step 4, an example of the proper bit control for selecting sink port 2 is 0000 0010.

For step 6, an example of the proper bit control for selecting source port B, enabling TMDS outputs and DDC link of the sink port 2 without 3.5dB de-emphasis is 0000 1001.

## Example - Reading From the TMDS442

The read operation consists of two phases. The first phase is the address phase. In this phase, an I<sup>2</sup>C master initiates a write operation to the TMDS442 by generating a start condition (S) followed by the TMDS442 I<sup>2</sup>C address, in MSB first bit order, followed by a 0 to indicate a write cycle. After receiving acknowledges from the TMDS442, the master presents the sub-address (sink port) of the register it wants to read. After the cycle is acknowledged (A), the master terminates the cycle immediately by generating a stop condition (P).

The second phase is the data phase. In this phase, an I<sup>2</sup>C master initiates a read operation to the TMDS442 by generating a start condition followed by the TMDS442 I<sup>2</sup>C address (as shown below for a read operation), in MSB first bit order, followed by a 1 to indicate a read cycle. After an acknowledge from the TMDS442, the I<sup>2</sup>C master receives one byte of data from the TMDS442. After the data byte has been transferred from the TMDS442 to the master, the master generates a NOT-acknowledge followed by a stop. Similar to the write function, to read both sink ports steps 1 through 11 must be repeated for each and every sink port desired.

### TMDS Read Phase 1:

<b>STEP 1</b>	<b>0</b>
I <sup>2</sup> C Start (Master)	S

<b>STEP 2</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
I <sup>2</sup> C General Address (Master)	0	1	0	1	1	X	X	0

Where each X logic state is defined by I2C-A1 and I2C-A0 pins being tied to either Vs+ or GND.

<b>STEP 3</b>	<b>9</b>
I <sup>2</sup> C Acknowledge (Slave)	A

<b>STEP 4</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
I <sup>2</sup> C Read Sink Port Address (Master)	0	0	0	0	0	0	Addr	Addr

Where Addr is determined by the values shown in [Table 2](#).

<b>STEP 5</b>	<b>9</b>
I <sup>2</sup> C Acknowledge (Slave)	A

<b>STEP 6</b>	<b>0</b>
I <sup>2</sup> C Stop (Master)	P

### TMD5442 Read Phase 2:

<b>STEP 7</b>	<b>0</b>
I <sup>2</sup> C Start (Master)	S

<b>STEP 8</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
I <sup>2</sup> C General Address (Master)	0	1	0	1	1	X	X	1

Where X logic state is defined by I2C-A1 and I2C-A0 pins being tied to either Vs+ or GND.

<b>STEP 9</b>	<b>9</b>
I <sup>2</sup> C Acknowledge (Slave)	A

<b>STEP 10</b>	<b>7</b>	<b>6</b>	<b>5</b>	<b>4</b>	<b>3</b>	<b>2</b>	<b>1</b>	<b>0</b>
I <sup>2</sup> C Read Data (Slave)	Data	Data	Data	Data	Data	Data	Data	Data

Where Data is determined by the logic values contained in the Sink Port Register.

<b>STEP 11</b>	<b>9</b>
I <sup>2</sup> C Not-Acknowledge (Master)	A

<b>STEP 12</b>	<b>0</b>
I <sup>2</sup> C Stop (Master)	P

## Supply Voltage

All V<sub>CC</sub> pins can be tied to a single 3.3-V power source. A 0.01-μF capacitor is connected from each V<sub>CC</sub> pin directly to ground to filter supply noise.

## TMD5 Inputs

Standard TMD5 terminations are integrated on all TMD5 inputs. External terminations are not required. Each input channel contains an 8-dB equalization circuit to compensate for cable losses. The voltage at the TMD5 input pins must be limited per the absolute maximum ratings. An unused input should not be connected to ground as this would result in excessive current flow damaging the device. TMD5 input pins do not incorporate failsafe circuits. An unused input channel can be externally biased to prevent output oscillation. The complementary input pin is recommended to be grounded through a 1-kΩ resistor and the other pin left open.

## TMDS Outputs

A 1% precision resistor, 4.64-k $\Omega$ , connected from VSADJ to ground is recommended to allow the differential output swing to provide TMDS signal levels. The differential output driver provides a typical 10-mA current sink capability, which provides a typical 500-mV voltage drop across a 50- $\Omega$  termination resistor. A 10% accuracy resistor is allowed to be connected when the output swing is not strictly required to meet the TMDS signal levels. A 10% resistor provides differential output voltages in the range of 438 mV and 532 mV.

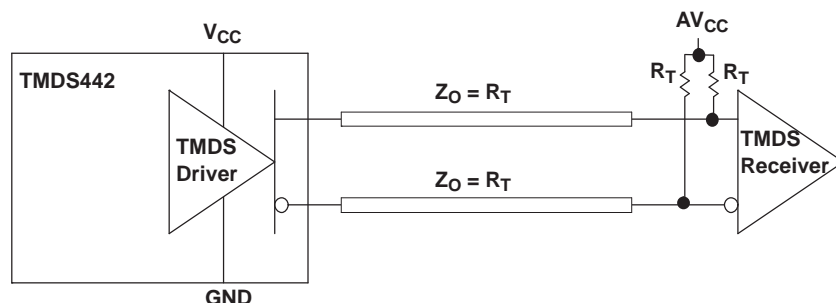


Figure 31. TMDS Driver and Termination Circuit

Referring to Figure 31, if both  $V_{CC}$  (TMDS442 supply) and  $AV_{CC}$  (sink termination supply) are both powered, the TMDS output signals are high impedance when  $\overline{OE}$  = high. Both supplies being active is the normal operating condition.

Again refer to Figure 31, if  $V_{CC}$  is on and  $AV_{CC}$  is off, the TMDS outputs source a typical 5-mA current through each termination resistor to ground. A total of 10-mW of power is consumed by the terminations independent of the  $\overline{OE}$  logical selection. When  $AV_{CC}$  is powered on, normal operation ( $\overline{OE}$  controls output impedance) is resumed.

When the power source of the device is off and the power source to termination is on, the  $I_{O(off)}$ , output leakage current, specification ensures the leakage current is limited 10- $\mu$ A or less.

The PRE pin provides 3dB de-emphasis, allowing output signal pre-conditioning to offset interconnect losses from the TMDS442 outputs to a TMDS receiver. PRE is recommended to be set low while connecting to a receiver throw short PCB route.

## HPD Pins

The HPD signals (HPD1, HPD2, HPD3) have an output impedance of 47- $\Omega$  typically. In certain applications, a 931- $\Omega$  resistor from the HPD output to the connector pin is recommended, to increase the output resistance to 1-K $\Omega$  +/- 20%.

## DDC Channels

The DDC channels are designed using I<sup>2</sup>C drivers with 5-V signal tolerance, allowing direct connection to standard I<sup>2</sup>C buses.

## Dual-Link 2-to-1 Switch Configurations

TMDS442 can be simply configured to operate as a dual-link DVI/HDMI, 2-to-1 switch, by configuring the device as follows, see Figure 32:

1. Set SA1 = low and SA2 = high
2. Set SB1 = SB2
3. When the 5V\_SINK1, HPD\_SINK1, SCL\_SINK1, and SDA\_SINK1 are selected as the control channels from/to the SINK, connect the 5V\_PWR1, HPD1, SCL1, and SDA1 to the dual-link source 1, and connect the 5V\_PWR3, HPD3, SCL3, and SDA3 to the dual-link source 2.
4. When the 5V\_SINK2, HPD\_SINK2, SCL\_SINK2, and SDA\_SINK2 are selected as the control channels from/to the SINK, connect the 5V\_PWR2, HPD2, SCL2, and SDA2 to the dual-link source 1, and connect the 5V\_PWR4, HPD4, SCL4, and SDA4 to the dual-link source 2.

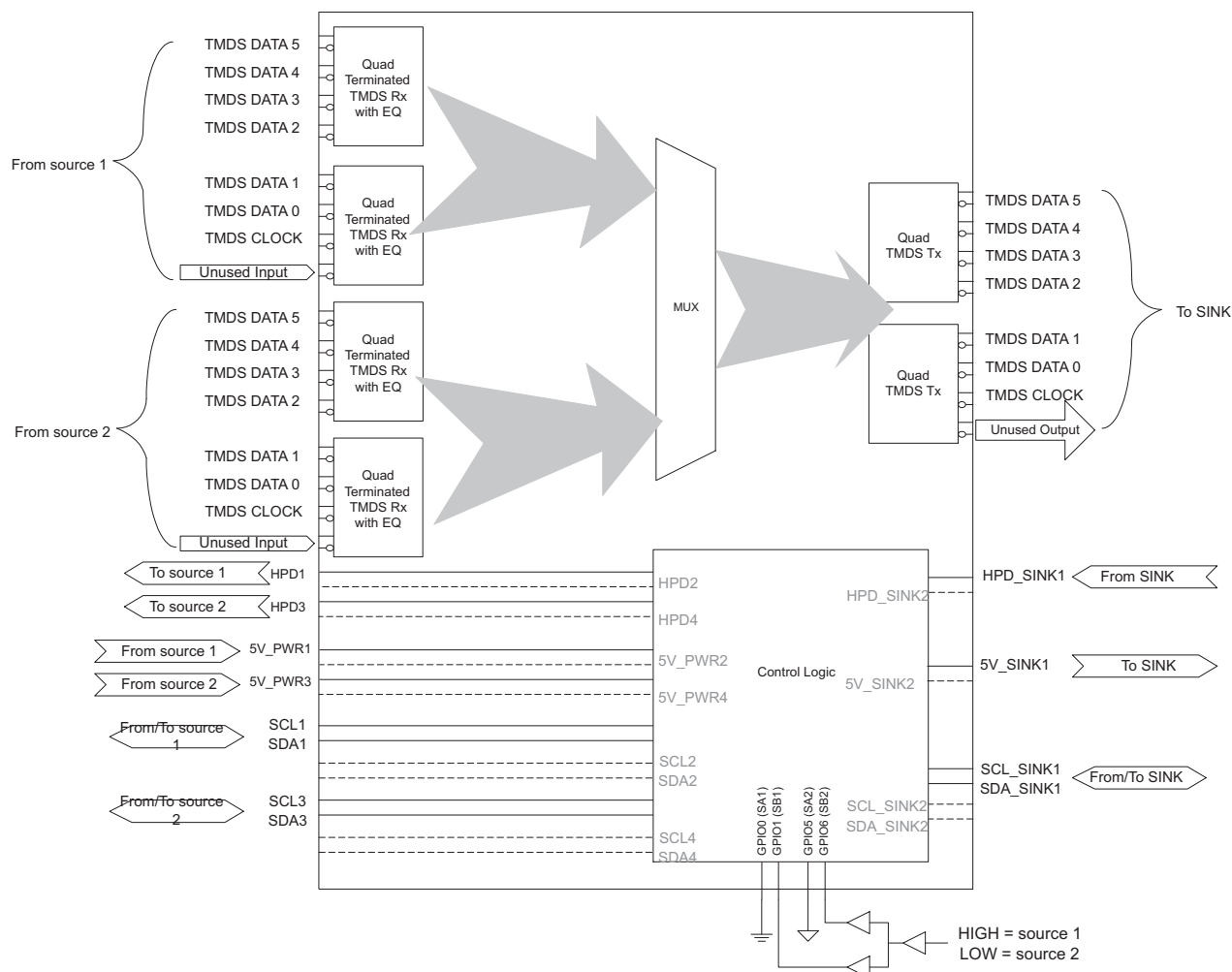


Figure 32. Dual-Link 2-to-1 DVI/HDMI Switch Configuration

In a dual link application, the unused TMDS input should be configured as follows: the complementary input pin is grounded through a 1-k $\Omega$  resistor, and the other pin left open.

## Layout Considerations

The high-speed TMDS inputs are the most critical paths for the TMDS442. There are several considerations to minimize discontinuities on these transmission lines between the connectors and the device:

- The TMDS differential inputs should be layout in the shortest stubs from connectors directly
- Maintain 100- $\Omega$  differential impedance into and out of the TMDS442
- Keep an uninterrupted ground plane beneath the high-speed I/Os
- Keep the ground-path vias to the device as close as possible to allow the shortest return current path

## I<sup>2</sup>C Function Description

The SCL/SDA and SCL\_SINK/SDA\_SINK pins are 5-V tolerant when the device is powered off and high impedance under low supply voltage, 1.5 V or below. If the device is powered up and the I<sup>2</sup>C circuits are enabled, and EN = high, the driver T (see Figure 33) is turned on or off depending up on the corresponding R side voltage level.

When the R side is pulled low below 1.5 V, the corresponding T side driver turns on and pulls the T side down to a low level output voltage, V<sub>OL</sub>. The value of V<sub>OL</sub> depends on the input to the OVS pin. When OVS is left floating



or not connected,  $V_{OL}$  is typically 0.5 V. When OVS is connected to GND,  $V_{OL}$  is typically 0.65 V. When OVS is connected to  $V_{CC}$ ,  $V_{OL}$  is typically 0.8 V.  $V_{OL}$  is always higher than the driver R input threshold,  $V_{IL}$ , which is typically 0.4 V, preventing lockup of the repeater loop. The  $V_{OL}$  value can be selected to improve or optimize noise margins between  $V_{OL}$  and the  $V_{IL}$  of the repeater itself or the  $V_{IL}$  of some external device connected on the T side.

When the R side is pulled up, above 1.5 V, the T side driver turns off and the T side pin is high impedance.

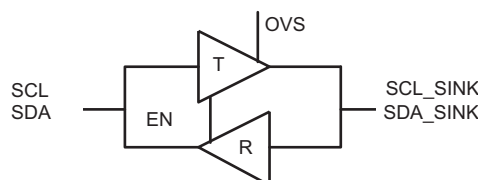


Figure 33. I²C Drivers in TMDS442

When the T side is pulled below 0.4 V by an external I²C driver, both drivers R and T are turned on. Driver R pulls the R side to near 0 V, and driver T is on, but is overridden by the external I²C driver. If driver T is already on, due to a low on the R side, driver R just turns on.

When the T side is released by the external I²C driver, driver T is still on, so the T side is only able to rise to the  $V_{OL}$  of driver T. Driver R turns off, since  $V_{OL}$  is above its 0.4-V  $V_{IL}$  threshold, releasing the R side. If no external I²C driver is keeping the R side low, the R side rises, and driver T turns off once the R side rises above 1.5 V, see Figure 34.

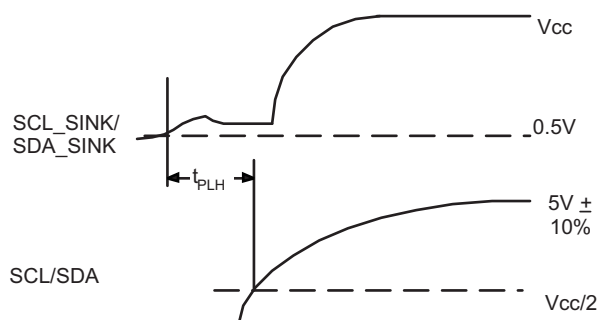


Figure 34. Waveform of Turning Driver T Off

It is important that any external I²C driver on the T side is able to pull the bus below 0.4 V to ensure full operation. If the T side cannot be pulled below 0.4 V, driver R may not recognize and transmit the low value to the R side.

## I²C Enable

The I²C drivers are enabled with an internal EN signal. This EN signal is the AND gate result of the 5V\_PWR signal from the selected input port and the I2CEN signal for the output. This AND gate is turned on based on an OR gate result of the GE and the 5V\_EN settings.

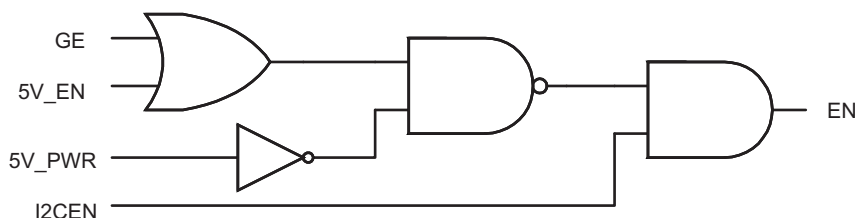


Figure 35. I²C Enable Equivalent Logic

When GE sets high, or GE sets low and 5V\_EN sets high, the EN signal is the AND result of the 5V\_PWR and the I2CEN. When GE sets low and 5V\_EN sets low, the EN signals follows the status of I2CEN. See [Table 5](#).

**Table 5. Truth Table for the EN Signal of the I<sup>2</sup>C Driver**

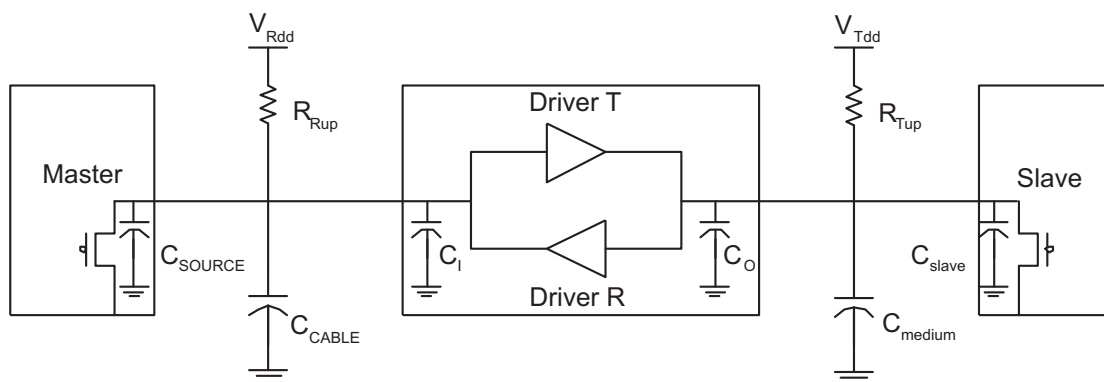
GE	5V_EN <sup>(1)</sup>	5V_PWR	I2CEN	EN
1	X	1	1	1
1	X	1	0	0
1	X	0	1	0
1	X	0	0	0
0	1	1	1	1
0	1	1	0	0
0	1	0	1	0
0	1	0	0	0
0	0	1	1	1
0	0	1	0	0
0	0	0	1	1
0	0	0	0	0

(1) X is 1 or 0

The I2CEN pin is active-high with an internal pull-up to V<sub>CC</sub>. It can be used to isolate a badly behaved slave during powering up. It should never change state during an I<sup>2</sup>C operation because disabling during a bus operation may hang the bus and enabling part way through a bus cycle could confuse the I<sup>2</sup>C parts being enabled.

## I<sup>2</sup>C Behavior

The typical application of the TMDS442 is as a repeater in a TV connecting the HDMI input connector and an internal HDMI Rx through flat cables. The I<sup>2</sup>C repeater is 5-V tolerant, and no additional circuitry is required to translate between 3.3-V to 5-V bus voltages. In the following example, the system master is running on an R-side I<sup>2</sup>C-bus while the slave is connected to a T-side bus. Both buses run at 100 kHz supporting standard-mode I<sup>2</sup>C operation. Master devices can be placed on either bus.



**Figure 36. Typical Application**

[Figure 37](#) illustrates the waveforms seen on the R-side I<sup>2</sup>C-bus when the master writes to the slave through the I<sup>2</sup>C repeater circuit of the TMDS442. This looks like a normal I<sup>2</sup>C transmission, and the turn on and turn off of the acknowledge signals are slightly delayed.

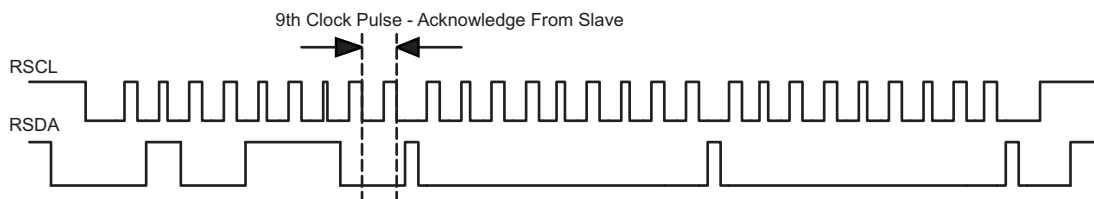


Figure 37. Bus R Waveform

Figure 38 illustrates the waveforms seen on the T-side I<sup>2</sup>C-bus under the same operation in Figure 37. On the T-side of the I<sup>2</sup>C repeater, the clock and data lines would have a positive offset from ground equal to the  $V_{OL}$  of the driver T. After the 8th clock pulse, the data line is pulled to the  $V_{OL}$  of the slave device which is very close to ground in this example. At the end of the acknowledge, the slave device releases and the bus level rises back to the  $V_{OL}$  set by the driver until the R-side rises above  $V_{CC}/2$ , after which it continues to high. It is important to note that any arbitration or clock stretching events require that the low level on the T-side bus at the input of the TMDS442 I<sup>2</sup>C repeater is below 0.4 V to be recognized by the device and then transmitted to the R-side I<sup>2</sup>C bus.

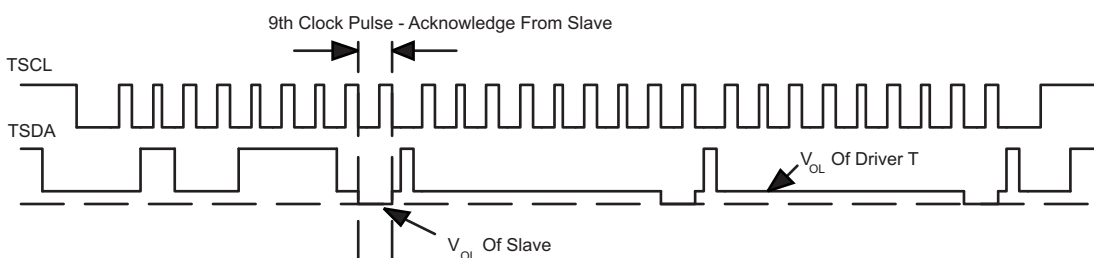


Figure 38. Bus T Waveform

The I<sup>2</sup>C circuitry inside the TMDS442 allows multiple stage operation as shown in Figure 39. I<sup>2</sup>C-Bus slave devices can be connected to any of the bus segments. The number of devices that can be connected in series is limited by repeater delay/time of flight considerations for the maximum bus speed requirements.

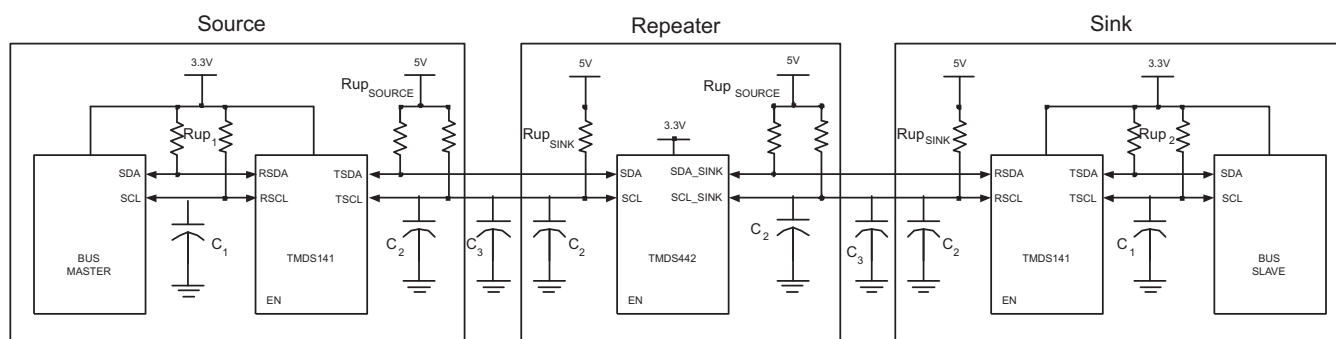


Figure 39. Typical Series Application

## I<sup>2</sup>C Pull-up Resistors

The pull-up resistor value is determined by two requirements:

1. The maximum sink current of the I<sup>2</sup>C buffer:

The maximum sink current is 3 mA or slightly higher for an I<sup>2</sup>C driver supporting standard-mode I<sup>2</sup>C operation.

$$R_{up(min)} = V_{DD}/I_{sink}$$

(1)

2. The maximum transition time on the bus:

The maximum transition time,  $T_r$ , of an I<sup>2</sup>C bus is set by an RC time constant, where R is the pull-up resistor

value, and C is the total load capacitance. The parameter, k, can be calculated from equation 3 by solving for t, the times at which certain voltage thresholds are reached. Different input threshold combinations introduce different values of t. [Table 6](#) summarizes the possible values of k under different threshold combinations.

$$T = k \times RC \quad (2)$$

$$V(t) = V_{DD}(1 - e^{-t/RC}) \quad (3)$$

**Table 6. Value K Upon Different Input Threshold Voltages**

$V_{th-} \backslash V_{th+}$	$0.7V_{DD}$	$0.65V_{DD}$	$0.6V_{DD}$	$0.55V_{DD}$	$0.5V_{DD}$	$0.45V_{DD}$	$0.4V_{DD}$	$0.35V_{DD}$	$0.3V_{DD}$
$0.1V_{DD}$	1.0986	0.9445	0.8109	0.6931	0.5878	0.4925	0.4055	0.3254	0.2513
$0.15V_{DD}$	1.0415	0.8873	0.7538	0.6360	0.5306	0.4353	0.3483	0.2683	0.1942
$0.2V_{DD}$	0.9808	0.8267	0.6931	0.5754	0.4700	0.3747	0.2877	0.2076	0.1335
$0.25V_{DD}$	0.9163	0.7621	0.6286	0.5108	0.4055	0.3102	0.2231	0.1431	0.0690
$0.3V_{DD}$	0.8473	0.6931	0.5596	0.4418	0.3365	0.2412	0.1542	0.0741	-

From equation 1,  $R_{up(min)} = 5.5V/3mA = 1.83\text{ k}\Omega$  to operate the bus under a 5-V pull-up voltage and provide less than 3 mA when the I<sup>2</sup>C device is driving the bus to a low state. If a higher sink current, for example 4 mA, is allowed,  $R_{up(min)}$  can be as low as 1.375 k $\Omega$ .

Given a 5-V I<sup>2</sup>C device with input low and high threshold voltages at  $0.3 V_{dd}$  and  $0.7 V_{dd}$ , the value of k is 0.8473 from [Table 6](#). Taking into account the 1.83-k $\Omega$  pull-up resistor, the maximum total load capacitance is  $C_{(total-5V)} = 645\text{ pF}$ .  $C_{cable(max)}$  should be restricted to be less than 545 pF if  $C_{source}$  and  $C_i$  can be as heavy as 50 pF. Here the  $C_i$  is treated as  $C_{sink}$ , the load capacitance of a sink device.

Fixing the maximum transition time from [Table 6](#),  $T = 1\text{ }\mu s$ , and using the k values from [Table 6](#), the recommended maximum total resistance of the pull-up resistors on an I<sup>2</sup>C bus can be calculated for different system setups.

To support the maximum load capacitance specified in the HDMI spec,  $C_{cable(max)} = 700pF/C_{source} = 50pF/C_i = 50pF$ ,  $R_{(max)}$  can be calculated as shown in [Table 7](#).

**Table 7. Pull-Up Resistor Upon Different Threshold Voltages and 800-pF Loads**

$V_{th-} \backslash V_{th+}$	$0.7V_{DD}$	$0.65V_{DD}$	$0.6V_{DD}$	$0.55V_{DD}$	$0.5V_{DD}$	$0.45V_{DD}$	$0.4V_{DD}$	$0.35V_{DD}$	$0.3V_{DD}$	UNIT
$0.1V_{DD}$	1.14	1.32	1.54	1.80	2.13	2.54	3.08	3.84	4.97	k $\Omega$
$0.15V_{DD}$	1.20	1.41	1.66	1.97	2.36	2.87	3.59	4.66	6.44	k $\Omega$
$0.2V_{DD}$	1.27	1.51	1.80	2.17	2.66	3.34	4.35	6.02	9.36	k $\Omega$
$0.25V_{DD}$	1.36	1.64	1.99	2.45	3.08	4.03	5.60	8.74	18.12	k $\Omega$
$0.3V_{DD}$	1.48	1.80	2.23	2.83	3.72	5.18	8.11	16.87	-	k $\Omega$

Or, limiting the maximum load capacitance of each cable to be 400 pF to accommodate with I<sup>2</sup>C spec version 2.1.  $C_{cable(max)} = 400pF/C_{source} = 50pF/C_i = 50pF$ , the maximum values of R are calculated as shown in [Table 8](#).

**Table 8. Pull-Up Resistor Upon Different Threshold Voltages and 500-pF Loads**

$V_{th-} \backslash V_{th+}$	$0.7V_{DD}$	$0.65V_{DD}$	$0.6V_{DD}$	$0.55V_{DD}$	$0.5V_{DD}$	$0.45V_{DD}$	$0.4V_{DD}$	$0.35V_{DD}$	$0.3V_{DD}$	UNIT
$0.1V_{DD}$	1.82	2.12	2.47	2.89	3.40	4.06	4.93	6.15	7.96	k $\Omega$
$0.15V_{DD}$	1.92	2.25	2.65	3.14	3.77	4.59	5.74	7.46	10.30	k $\Omega$
$0.2V_{DD}$	2.04	2.42	2.89	3.48	4.26	5.34	6.95	9.63	14.98	k $\Omega$
$0.25V_{DD}$	2.18	2.62	3.18	3.92	4.93	6.45	8.96	13.98	28.99	k $\Omega$
$0.3V_{DD}$	2.36	2.89	3.57	4.53	5.94	8.29	12.97	26.99	-	k $\Omega$

Obviously, to accommodate the 3-mA drive current specification, a narrower threshold voltage range is required to support a maximum 800-pF load capacitance for a standard-mode I<sup>2</sup>C bus.

When the input low and high level threshold voltages,  $V_{th-}$  and  $V_{th+}$ , are 0.7 V and 1.9 V, which is  $0.15 V_{DD}$  and  $0.4 V_{DD}$  approximately with  $V_{DD} = 5\text{ V}$ , from [Table 7](#), the maximum pull-up resistor is 3.59 k $\Omega$ . The allowable pull-up resistor is in the range of 1.83 k $\Omega$  and 3.59 k $\Omega$ .

## Thermal Dissipation

High-K board – It is always recommended to solder the PowerPAD™ onto the thermal land. A thermal land is the area of solder-tinned-copper underneath the PowerPAD package. Thermal simulation shows the  $\theta_{JA}$  of the TMDS442 is 23.2°C/W on a high-K board with a 4 x 4 thermal via array, or is 29.4°C/W under the same condition without a via array. The maximum junction temperature is 103°C with via arrays and 112°C without via arrays when the maximum power dissipation from the device is 1.43W. The maximum recommended junction temperature is 125°C, allowing the TMDS442 to operate over the full temperature range (0°C - 70°C) when the PowerPAD is soldered onto the thermal land.

Low-K board – Simulation also shows the  $\theta_{JA}$  of the TMDS442 is 46.9°C/W on a low-K board with the PowerPAD soldered and no thermal vias. To ensure the maximum junction temperature does not exceed 125°C with a worst case power dissipation from the device of 1.43W, the ambient temperature needs to be lower than 58°C, when the device is placed on a low-K board.

A general PCB design guide to PowerPAD package is provided in slma002 - PowerPAD Thermally Enhanced Package.

## PACKAGE OPTION ADDENDUM

### PACKAGING INFORMATION 30-August-2006

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TMDS442PNP	ACTIVE	HTQFP	PNP	128	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
TMDS442PNPG4	ACTIVE	HTQFP	PNP	128	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

- The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

- Eco Plan -The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) -please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## Revision History

Changes from Original (August 2006) to Revision A	Page
• Changed HDMI 1.3 to HDMI 1.3a.....	1
• Changed 1.65 Gbps to 2.25 Gbps and 8-Bit to 12-Bit.....	1
• Changed 1.65 Gbps to 2.25 Gbps.....	1
• Changed 1.65 Gbps to 2.25 Gbps.....	7
• Added 2.25 Gbps Peak-to-peak output jitter from Y/Z(1), residual jitter.....	10
• Added 2.25 Gbps Peak-to-peak output jitter from Y/Z(2:4), residual jitter.....	10
• Changed RESIDUAL PEAK-TO-PEAK JITTER vs DATA RATE curves.....	18
• Changed RESIDUAL PEAK-TO-PEAK JITTER vs DATA RATE curves.....	18
• Changed RESIDUAL PEAK-TO-PEAK JITTER vs DATA RATE curves.....	19
• Added RESIDUAL PEAK-TO-PEAK JITTER vs DATA RATE curves.....	19

**TAPE AND REEL INFORMATION**

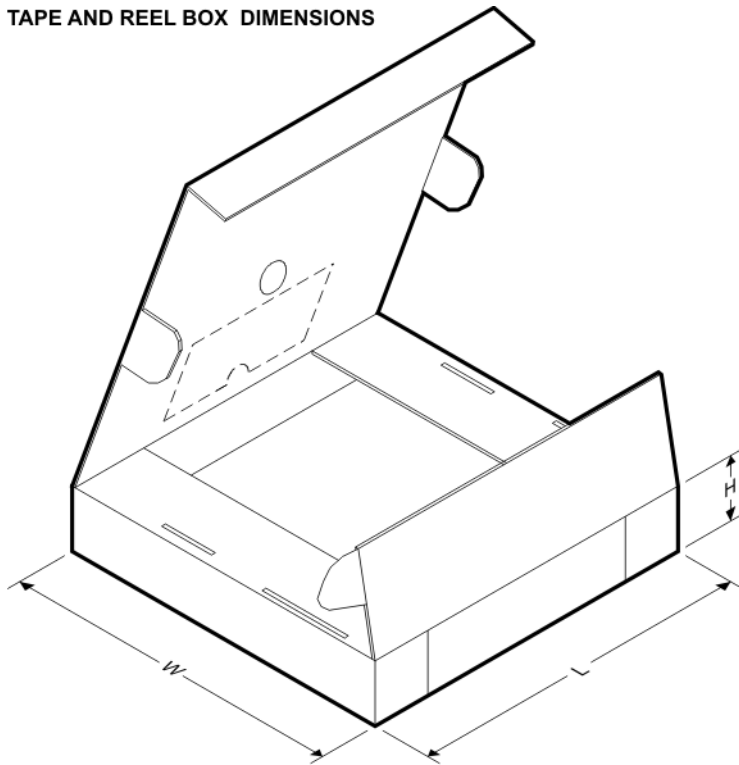


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMDS442PNPR	HTQFP	PNP	128	1000	330.0	24.4	16.6	16.6	2.0	20.0	24.0	Q2



## TAPE AND REEL BOX DIMENSIONS

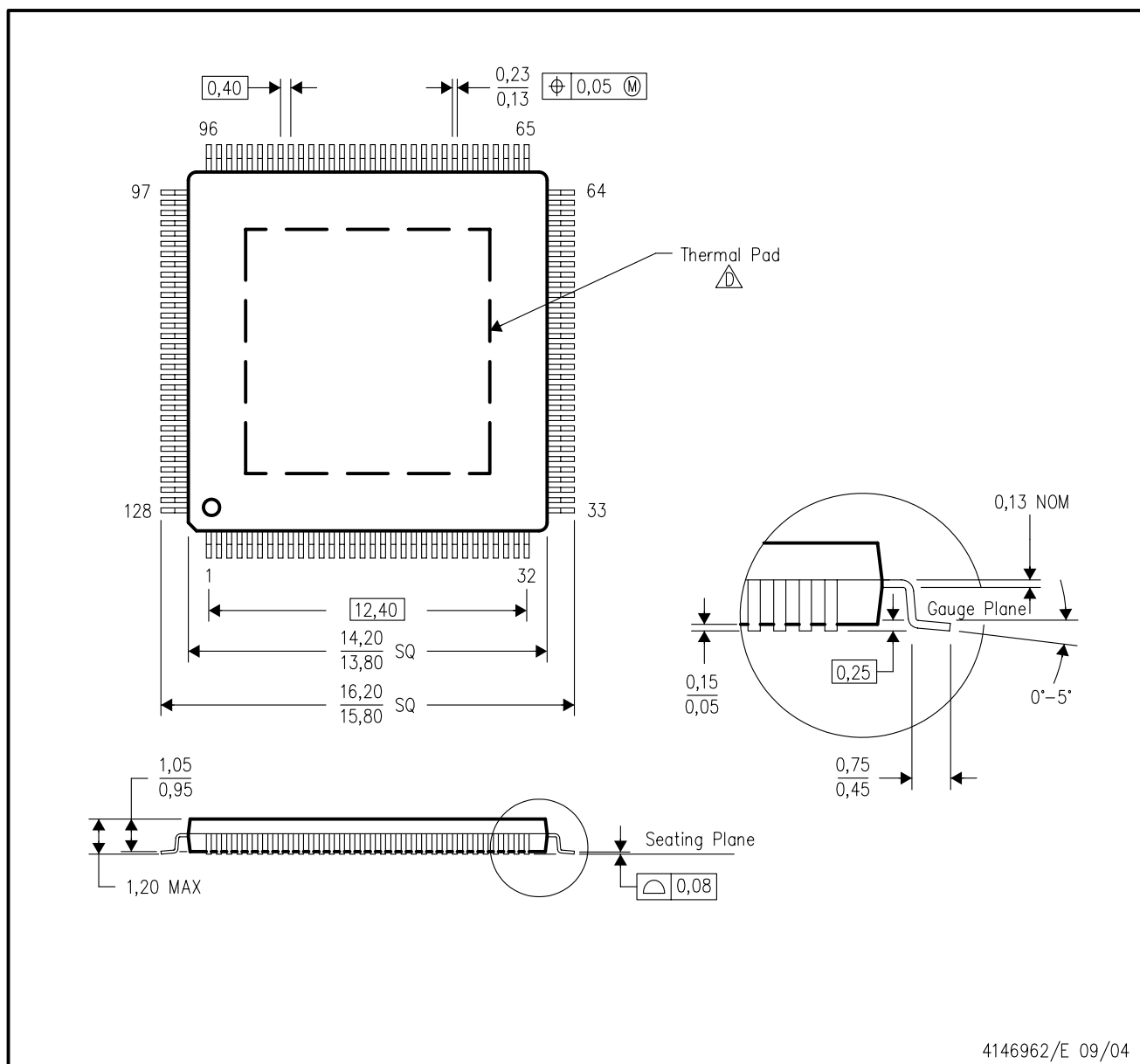


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMDS442PNPR	HTQFP	PNP	128	1000	346.0	346.0	41.0

PNP (S-PQFP-G128)

PowerPAD™ PLASTIC QUAD FLATPACK



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Body dimensions do not include mold flash or protrusion.
- ⚠ This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>. See the product data sheet for details regarding the exposed thermal pad dimensions.

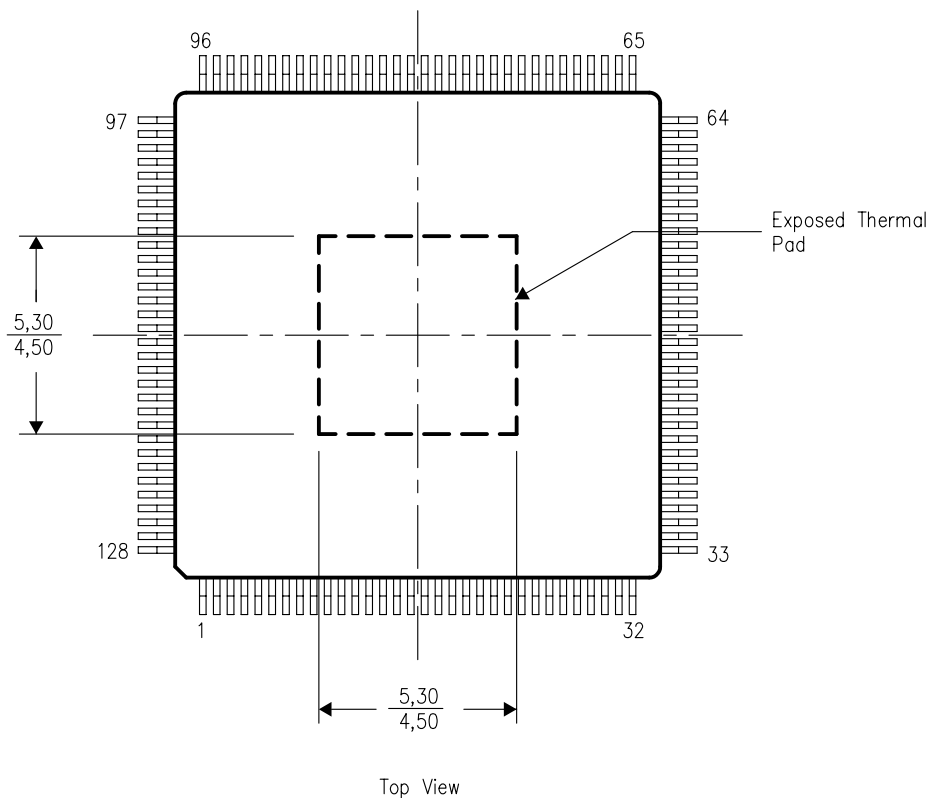
PowerPAD is a trademark of Texas Instruments.

## THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters

Exposed Thermal Pad Dimensions

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

### Products

Amplifiers	<a href="http://amplifier.ti.com">amplifier.ti.com</a>
Data Converters	<a href="http://dataconverter.ti.com">dataconverter.ti.com</a>
DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>
Clocks and Timers	<a href="http://www.ti.com/clocks">www.ti.com/clocks</a>
Interface	<a href="http://interface.ti.com">interface.ti.com</a>
Logic	<a href="http://logic.ti.com">logic.ti.com</a>
Power Mgmt	<a href="http://power.ti.com">power.ti.com</a>
Microcontrollers	<a href="http://microcontroller.ti.com">microcontroller.ti.com</a>
RFID	<a href="http://www.ti-rfid.com">www.ti-rfid.com</a>
RF/IF and ZigBee® Solutions	<a href="http://www.ti.com/lprf">www.ti.com/lprf</a>

### Applications

Audio	<a href="http://www.ti.com/audio">www.ti.com/audio</a>
Automotive	<a href="http://www.ti.com/automotive">www.ti.com/automotive</a>
Broadband	<a href="http://www.ti.com/broadband">www.ti.com/broadband</a>
Digital Control	<a href="http://www.ti.com/digitalcontrol">www.ti.com/digitalcontrol</a>
Medical	<a href="http://www.ti.com/medical">www.ti.com/medical</a>
Military	<a href="http://www.ti.com/military">www.ti.com/military</a>
Optical Networking	<a href="http://www.ti.com/opticalnetwork">www.ti.com/opticalnetwork</a>
Security	<a href="http://www.ti.com/security">www.ti.com/security</a>
Telephony	<a href="http://www.ti.com/telephony">www.ti.com/telephony</a>
Video & Imaging	<a href="http://www.ti.com/video">www.ti.com/video</a>
Wireless	<a href="http://www.ti.com/wireless">www.ti.com/wireless</a>

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265  
Copyright © 2008, Texas Instruments Incorporated